



TEST REPORT

100, Jangjateo-ro, Hobeop-myeon,
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Tel: 031-637-8898 / Fax: 0505-116-8895

1. Client

- Name : Sena Technologies Co., Ltd.
- Address..... : 19, Heolleung-ro 569-gil, Gangnam-gu, Seoul, Korea

2. Use of Report..... : FCC Approval

3. Sample Description

- Product Name : Wireless Communication Systems
- Model Name : 10R 2

4. Date of Receipt..... : 2025-06-10

5. Date of Test : 2025-08-05 ~ 2025-11-13

6. Test Method : FCC Part 15 Subpart C 15.247

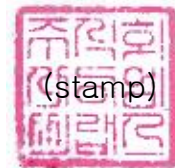
7. Test Results : Refer to the test results

- ※ The results shown in this test report are the results of testing the samples provided.
- ※ This test report is prepared according to the requirements of ISO / IEC 17025.

Affirmation	Tested by Dae-Seong, Choi  (Sign)	Technical Manager Jong-Myoung, Shin  (Sign)
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Nov 18, 2025

EMC Labs Co., Ltd.



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Version

TEST REPORT NO.	DATE	DESCRIPTION
KR0140-RF2511-002	Nov 18, 2025	Initial Issue



1. Applicant & Manufacturer & Test Laboratory Information

1.1 Applicant Information

Applicant	Sena Technologies Co., Ltd.
Applicant Address	19, Heolleung-ro 569-gil, Gangnam-gu, Seoul, Korea
Contact Person	Seunghyun Kim
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1.2. Manufacturer Information

Manufacturer	Sena Technologies Co., Ltd.
Manufacturer Address	19, Heolleung-ro 569-gil, Gangnam-gu, Seoul, Korea

1.3 Test Laboratory Information

Laboratory	EMC Labs Co., Ltd.
Laboratory Address	100, Jangjateo-ro, Hobeop-myeon, Icheon-si, Gyeonggi-do, Republic of Korea
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FCC Designation No.	KR0140
FCC Registration No.	580000
IC Site Registration No.	28751

2. Equipment under Test(EUT) Information

2.1 General Information

Product Name	Wireless Communication Systems
Model Name	10R 2
FCC ID	S7A-SP183
Rated Voltage	DC 3.7 V

2.2 Additional Information

Operating Frequency	2 402 MHz ~ 2 480 MHz
Number of channel	79
Modulation Type	BDR Mode(GFSK), EDR Mode(Pi/4 DQPSK, 8DPSK)
Antenna Type & Gain	Chip Antenna(with Max gain: 0.27 dBi)
Firmware Version	1.0
Hardware Version	1.0
Test software	BlueTest3 V3.3.18

2.3 Test Frequency

Test mode	Test Frequency (MHz)		
	Low Frequency	Middle Frequency	High Frequency
GFSK	2 402	2 441	2 480
Pi/4 DQPSK	2 402	2 441	2 480
8DPSK	2 402	2 441	2 480

2.4 Worst-Case

BDR	GFSK (DH5)
EDR	8DPSK (3-DH5)

Note: The power measurement has been conducted to determine the worst-case mode from all possible Combinations between available modulations, data rates.

2.5 Mode of operation during the test

- The EUT continuous transmission mode during the test with set at Low Channel, Middle Channel, and High Channel. To get a maximum radiated emission levels from the EUT, the EUT was moved throughout the XY, YZ, XZ planes.

2.6 Modifications of EUT

- None



3. Test Summary

Applied	FCC Rule	IC Rule	Test Items	Test Condition	Result
☒	15.203	–	Antenna Requirement	Conducted	C
☒	15.247(a)	–	20 dB Bandwidth		C
☒	–	RSS GEN (6.7)	Occupied Bandwidth (99%)		C
☒	15.247(a)	RSS-247 (5.1)	Number of Hopping Frequencies		C
☒	15.247(a)	RSS-247 (5.1)	Time of Occupancy (Dwell Time)		C
☒	15.247(a)	RSS-247 (5.1)	Carrier Frequencies Separation		C
☒	15.247(b)	RSS-247 (5.4)	Peak Output Power		C
☒	15.247(d)	RSS-247 (5.5)	Conducted Spurious Emission		C
☒	15.247(d) 15.205 & 15.209	RSS-247 (5.5) RSS-GEN (8.9 & 8.10)	Radiated Spurious Emission	Radiated	C
☒	15.207	RSS-GEN (8.8)	Conducted Emissions	AC Line Conducted	C

Note 1: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

The sample was tested according to the following specification: ANSI C63.10:2013.

Compliance was determined by specification limits of the applicable standard according to customer requirements.



4. Used equipment on test

	Description	Manufacturer	Model Name	Serial Name	Next Cal.
■	TEMP & HUMID CHAMBER	JFM	JFMA-001	20200929-01	2026.11.05
■	CONTROLLER	AMWON TECHNOLOGY	TEMI2500	S7800VK191 0707	2026.11.05
■	PSA SERIES SPECTRUM ANALYZER	AGILENT	E4440A	MY45304057	2026.11.05
■	MXG ANALOG SIGNAL GENERATOR	AGILENT	N5183A	MY50141890	2026.11.05
■	SYSTEM DC POWER SUPPLY	AGILENT	6674A	MY53000118	2026.11.05
□	VECTOR SIGNAL GENERATOR	ROHDE & SCHWARZ	SMBV100A	257524	2026.11.05
□	DIRECTIONAL COUPLER	AGILENT	773D	2839A01855	2026.11.05
□	ATTENUATOR	AGILENT	8493C	73193	2026.11.06
□	TERMINATION	HEWLETT PACKARD	909D	07492	2026.11.06
□	POWER DIVIDER	HEWLETT PACKARD	11636A	06916	2026.11.05
□	SLIDE-AC	DAEKWANG TECH	SV-1023	NONE	2026.11.05
■	DIGITAL MULTIMETER	HUMANTECHSTORE	15B+	50561541WS	2026.11.05
■	ATTENUATOR	ACE RF COMM	ATT SMA 20W 20dB 8GHz	A-0820.SM20.2	2026.04.04
■	DC POWER SUPPLY	AGILENT	E3634A	MY40012120	2026.02.13
□	USB Peak Power Sensor	Anritsu	MA24408A	12321	2026.11.05
□	High Pass Filter	WT Microwave INC.	WT-A3314-HS	WT22111804-1	2026.11.05
■	High Pass Filter	WT Microwave INC.	WT-A1935-HS	WT22111804-2	2026.11.05
□	SPECTRUM ANALYZER	ROHDE & SCHWARZ	FSU26	200444	2026.02.13
■	ATTENUATOR	Mini-Circuits	BW-K3-2W44+	2318-1	2026.02.13
□	ATTENUATOR	Mini-Circuits	BW-K3-2W44+	2318-2	2026.05.08
□	Balanced Temperature and Humidity Control System	ESPEC CORP.	SH-241	92004650	2026.05.07
■	ACTIVE LOOP ANTENNA	TESEQ	HLA 6121	55685	2026.12.20
■	Biconilog ANT	Schwarzbeck	VULB 9160	3260	2026.04.01
□	Biconilog ANT	Schwarzbeck	VULB9168	902	2026.08.28
■	Horn ANT	Schwarzbeck	BBHA9120D	974	2025.11.29
□	Horn ANT	Schwarzbeck	BBHA9120D	1497	2026.01.03
■	Amplifier	TESTEK	TK-PA18H	200104-L	2026.05.23
■	Horn ANT	Schwarzbeck	BBHA9170	01188	2026.03.20
□	Horn ANT	Schwarzbeck	BBHA9170	01189	2026.03.20
■	AMPLIFIER	TESTEK	TK-PA1840H	220105-L	2026.03.17
■	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESW44	101952	2026.03.17
■	Test Receiver	ROHDE & SCHWARZ	ESR7	101616	2026.06.25
■	TWO LINE V-NETWORK	ROHDE & SCHWARZ	ENV216	102596	2026.04.14
■	PULSE LIMITER	lignex1	EPL-30	NONE	2026.01.04



5. Antenna Requirement

According to §15.203 An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

According to §15.247(b)(4) e conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

5.1 Result

Complies

(The transmitter has a Chip Antenna. The directional peak gain of the antenna is 0.27 dBi.)



6. 20 dB Bandwidth & Occupied Bandwidth (99%)

6.1 Test Setup

Refer to the APPENDIX I.

6.2 Limit

Limit : Not Applicable

6.3 Test Procedure

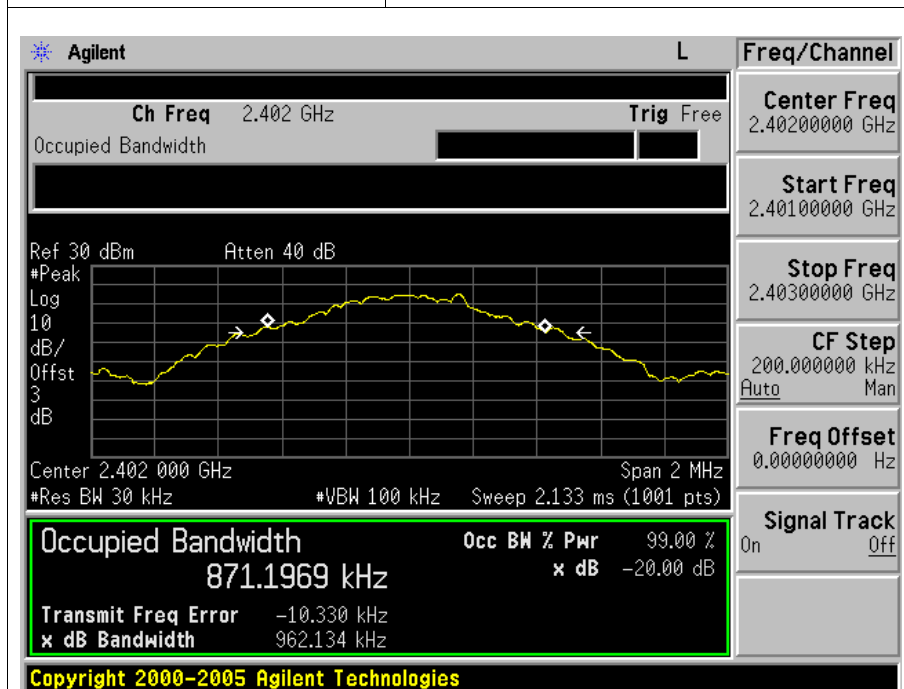
1. The 20 dB bandwidth & Occupied bandwidth were measured with a spectrum analyzer connected to RF antenna Connector (conducted measurement) while EUT was operating in transmit mode. The analyzer center frequency was set to the EUT carrier frequency, using the analyzer.
2. The bandwidth of the fundamental frequency was measured with the spectrum analyzer using below setting:
RBW = 1% to 5% of the 20 dB Bandwidth & Occupied Bandwidth
VBW $\geq 3 \times$ RBW
Span = between two times and five times the 20 dB Bandwidth & Occupied Bandwidth
Sweep = Auto
Detector function = Peak
Trace = Max Hold

6.4 Test Result

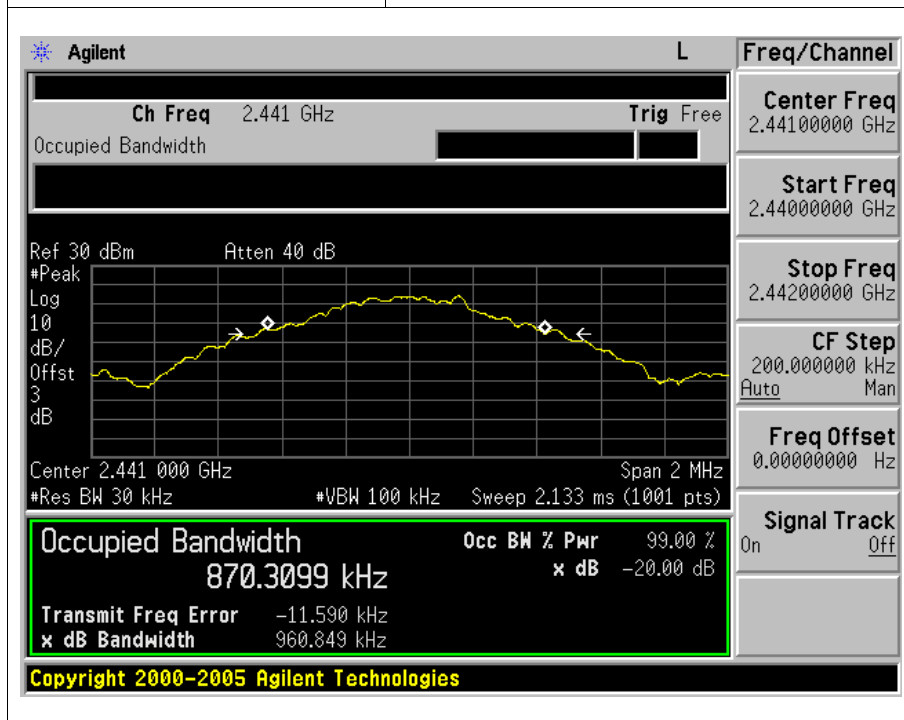
Test Mode	Test Frequency	20 dB Bandwidth (MHz)	Occupied Bandwidth (MHz)
GFSK	Low	0.962	0.871
	Middle	0.961	0.870
	High	0.960	0.865
8DPSK	Low	1.313	1.194
	Middle	1.315	1.195
	High	1.313	1.193

6.5 Test Plot

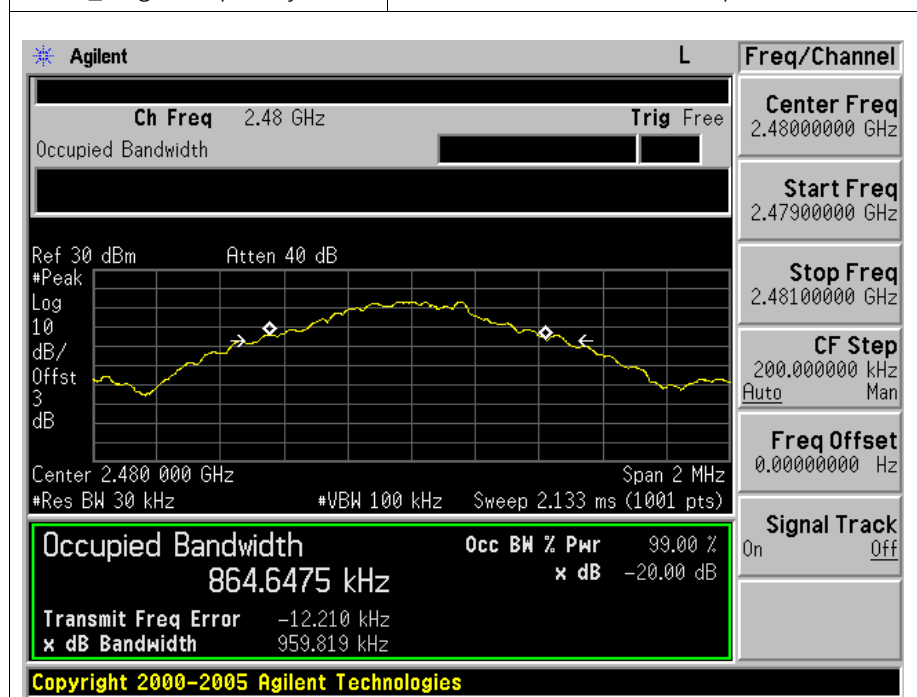
GFSK _ Low frequency 20 dB Bandwidth & Occupied Bandwidth



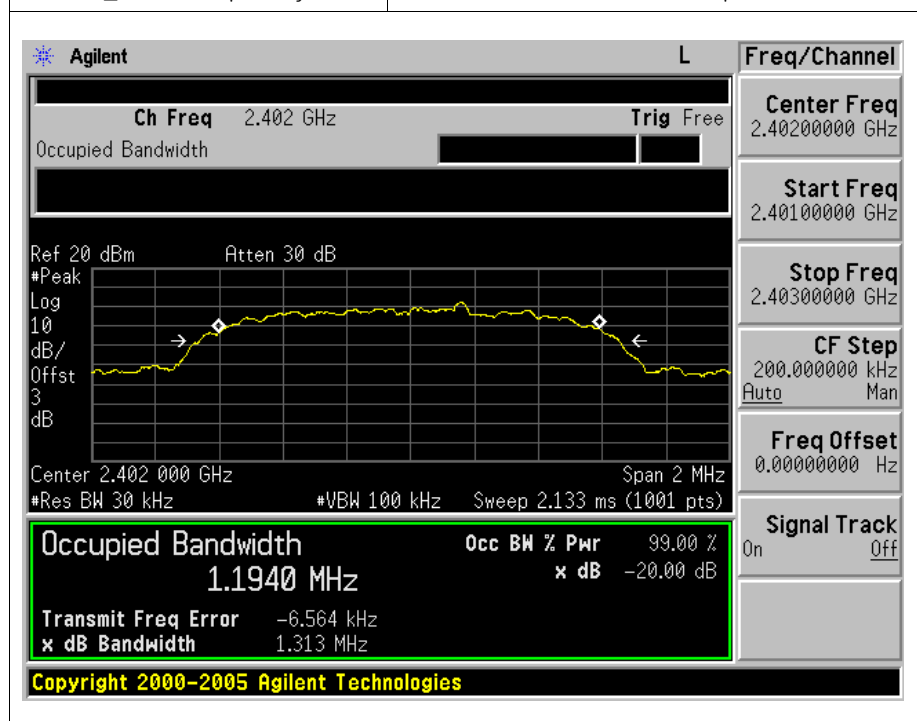
GFSK _ Middle frequency 20 dB Bandwidth & Occupied Bandwidth



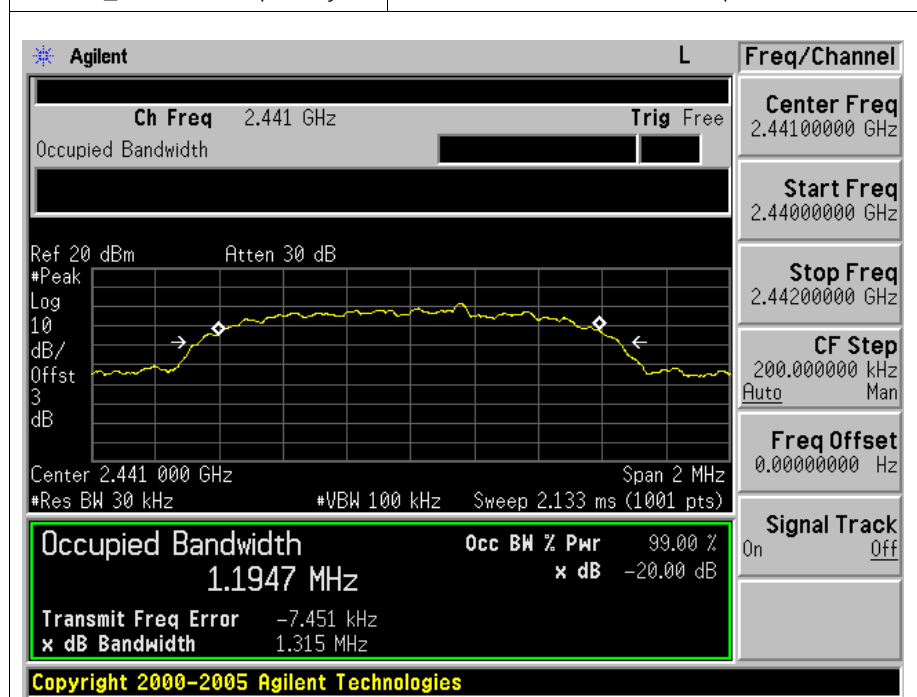
GFSK _ High frequency 20 dB Bandwidth & Occupied Bandwidth



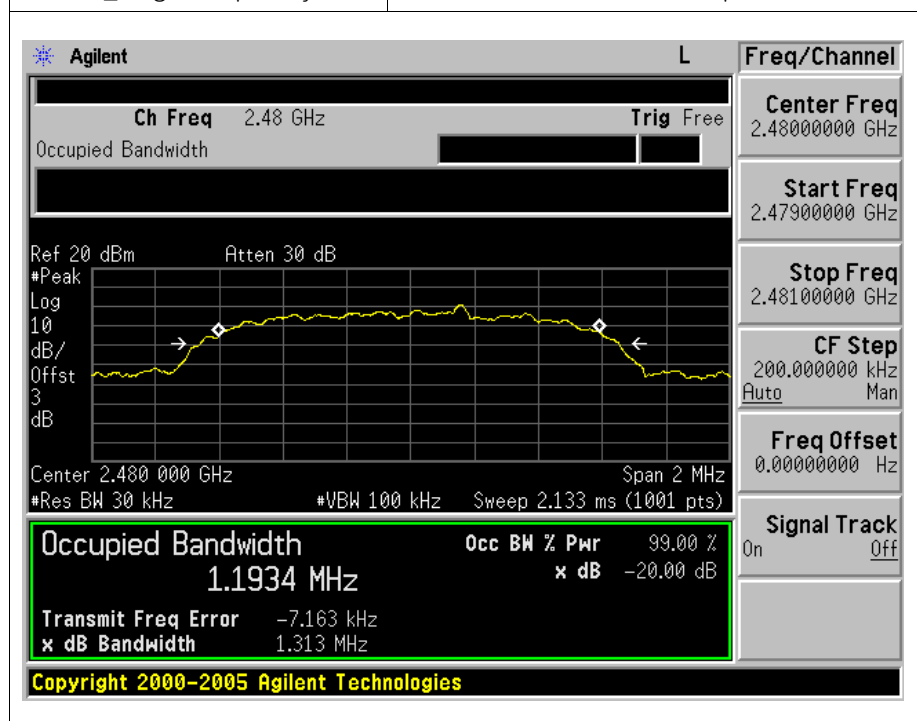
8DPSK _ Low frequency 20 dB Bandwidth & Occupied Bandwidth



8DPSK _ Middle frequency 20 dB Bandwidth & Occupied Bandwidth



8DPSK _ High frequency 20 dB Bandwidth & Occupied Bandwidth





7. Number of Hopping Frequencies

7.1 Test Setup

Refer to the APPENDIX I.

7.2 Limit

Limit : ≥ 15 hops

7.3 Test Procedure

The number of hopping frequencies was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

To get higher resolution, two frequency ranges for FH mode within the 2400 ~ 2483.5 MHz were examined.

The spectrum analyzer is set to:

Span = 50 MHz

RBW = To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.

VBW $\geq$ RBW

Sweep = Auto

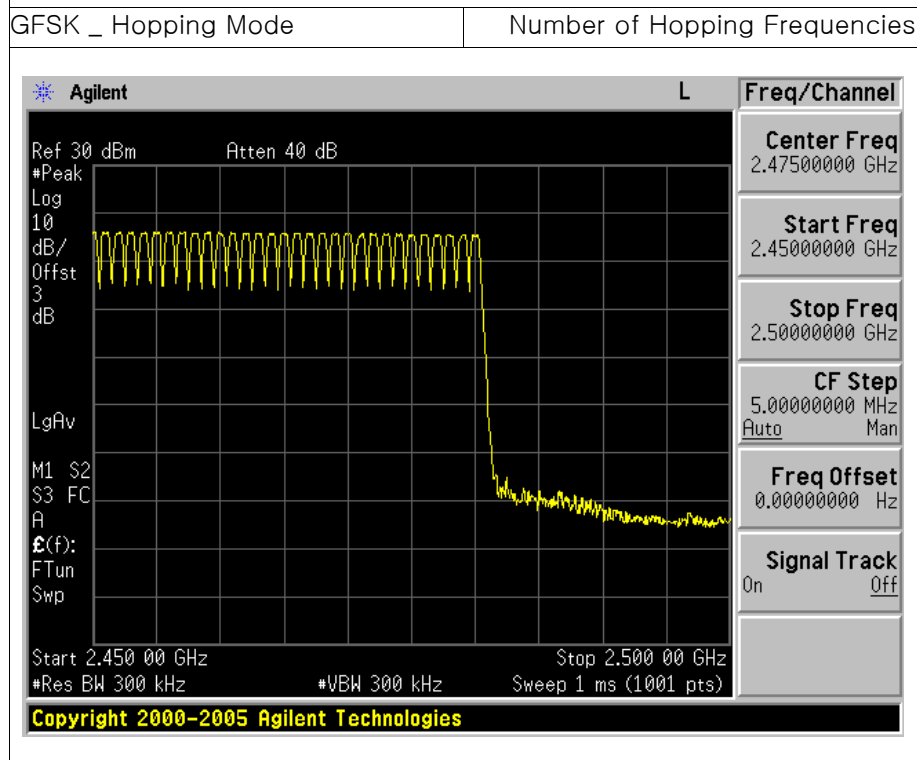
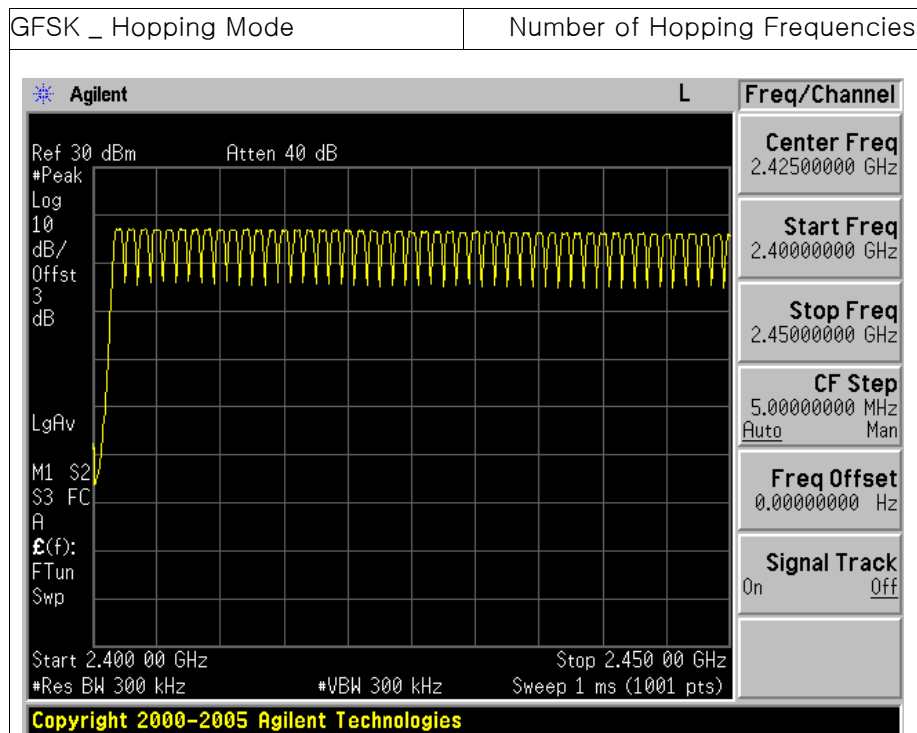
Detector = Peak

Trace = Max hold

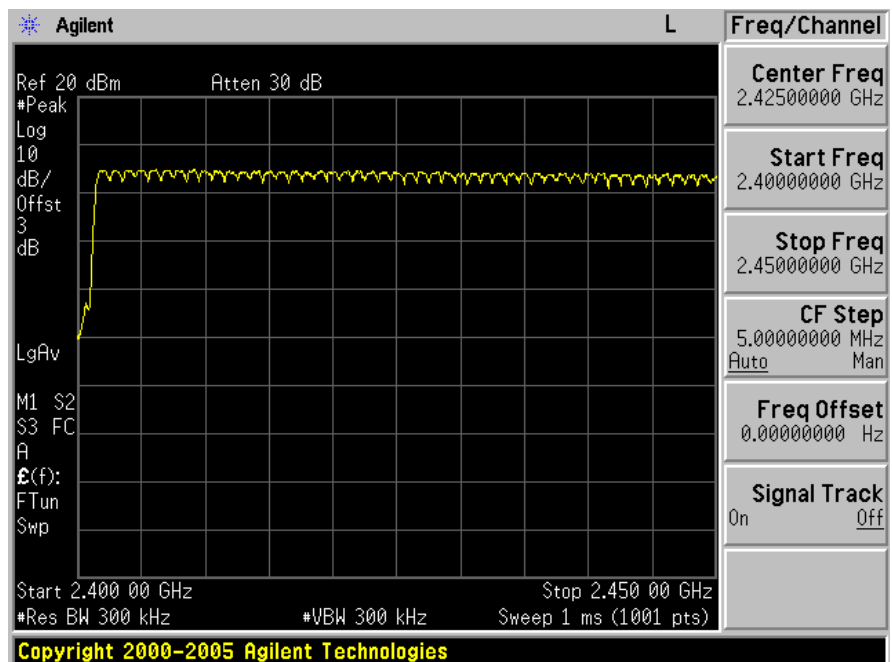
7.4 Test Result

Test Mode	Number of Hopping Channels
GFSK	79
8DPSK	79

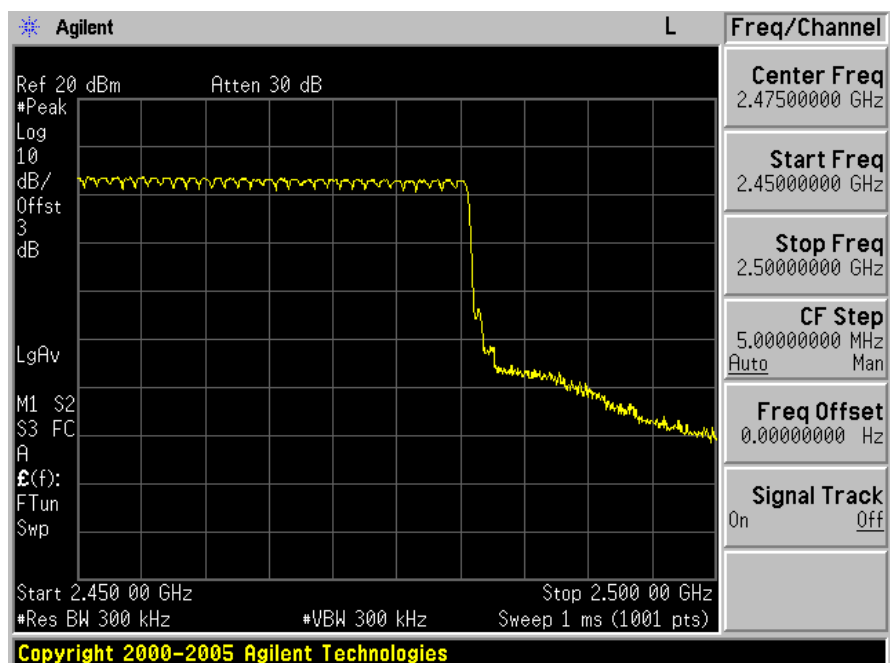
7.5 Test Plot



8DPSK _ Hopping Mode Number of Hopping Frequencies



8DPSK _ Hopping Mode Number of Hopping Frequencies





8. Time of Occupancy (Dwell Time)

8.1 Test Setup

Refer to the APPENDIX I.

8.2 Limit

The maximum permissible time of occupancy is 400 ms within a period of 400 ms multiplied by the number of hopping channels employed.

8.3 Test Procedure

The dwell time was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

The spectrum analyzer is set to:

Center frequency = 2441 MHz Span = Zero

RBW = 1 MHz (RBW shall be $\leq$ channel spacing and where possible RBW should be set $\gg 1 / T$, where T is the expected dwell time per channel)

VBW $\geq$ RBW Detector = Peak

Trace = Max hold

8.4 Test Result

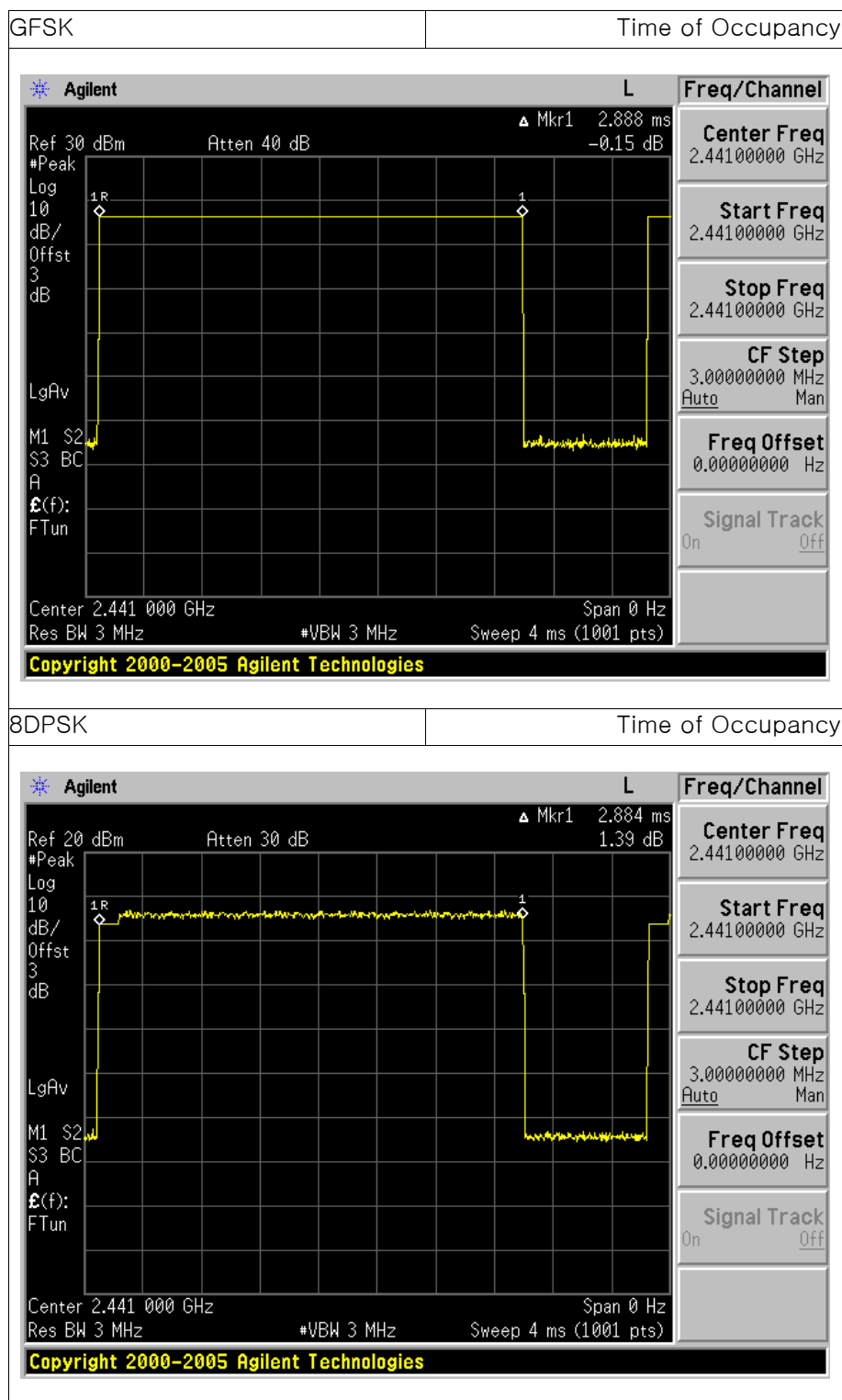
Test Mode	Number of Hopping Channels	Burst On Time (ms)	Result (sec)	Limit (sec)
GFSK (non-AFH)	79	2.888	0.31	0.40
GFSK (AFH)	20	2.888	0.15	0.40
8DPSK (non-AFH)	79	2.884	0.31	0.40
8DPSK (AFH)	20	2.884	0.15	0.40

Note: Dwell Time = $0.4 \times \text{Hopping channel} \times \text{Burst On Time} \times ((\text{Hopping rate} / \text{Time slots}) / \text{Hopping channel})$

- Time slots for DH5 = 6 slots (TX = 5 slot / RX = 1 slot)

- Hopping Rate = 1600 for FH mode & 800 for AFH mode

8.5 Test Plot





9. Carrier Frequencies Separation

9.1 Test Setup

Refer to the APPENDIX I.

9.2 Limit

Limit : ≥ 25 kHz or $\geq$ Two-Thirds of the 20 dB Bandwidth whichever is greater.

9.3 Test Procedure

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

After the trace being stable, the reading value between the peaks of the adjacent channels using the marker delta function was recorded as the measurement results.

The spectrum analyzer is set to:

Span = wide enough to capture the peaks of two adjacent channels

RBW = Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.

VBW $\geq$ RBW

Sweep = Auto

Detector = Peak

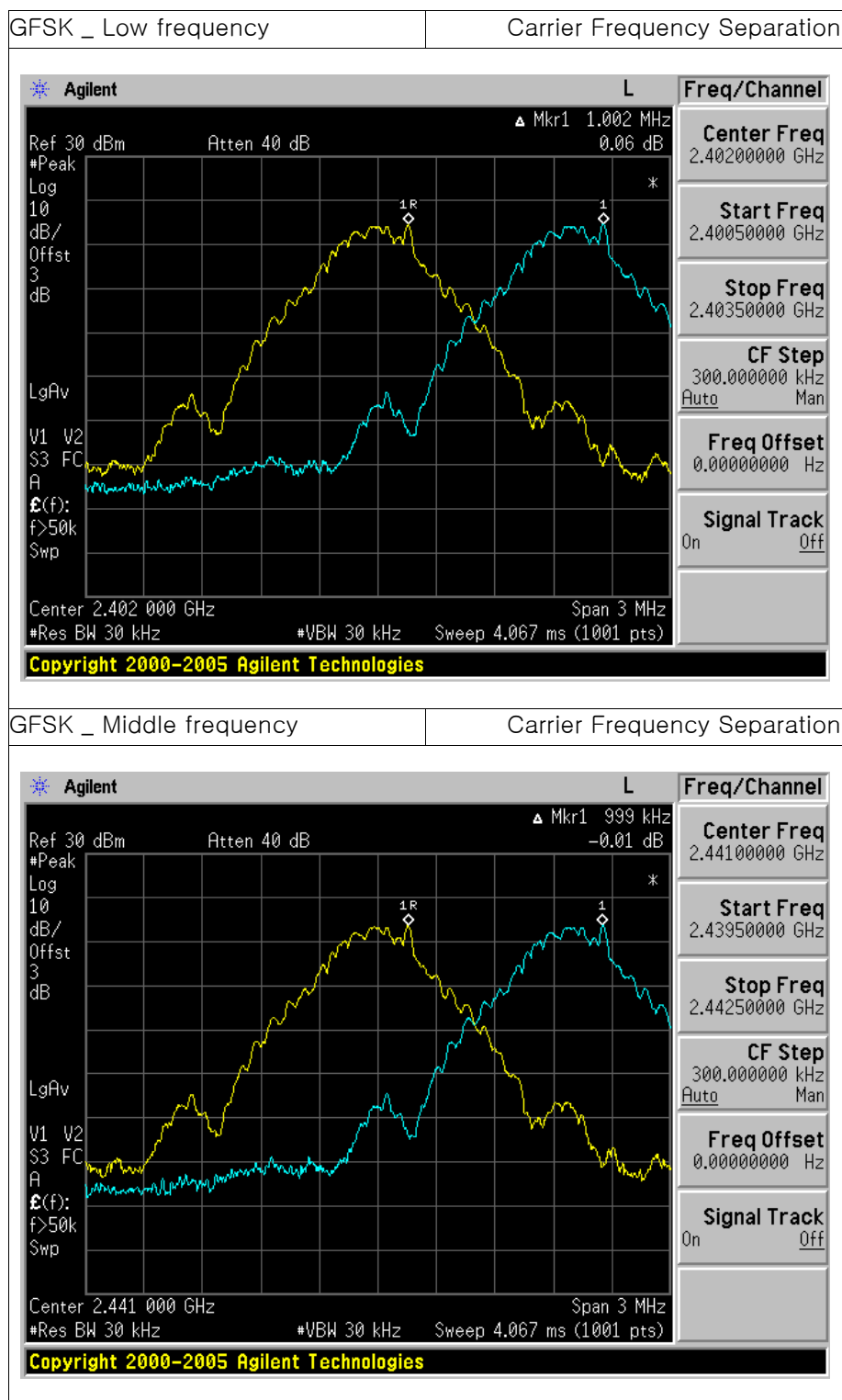
Trace = Max hold

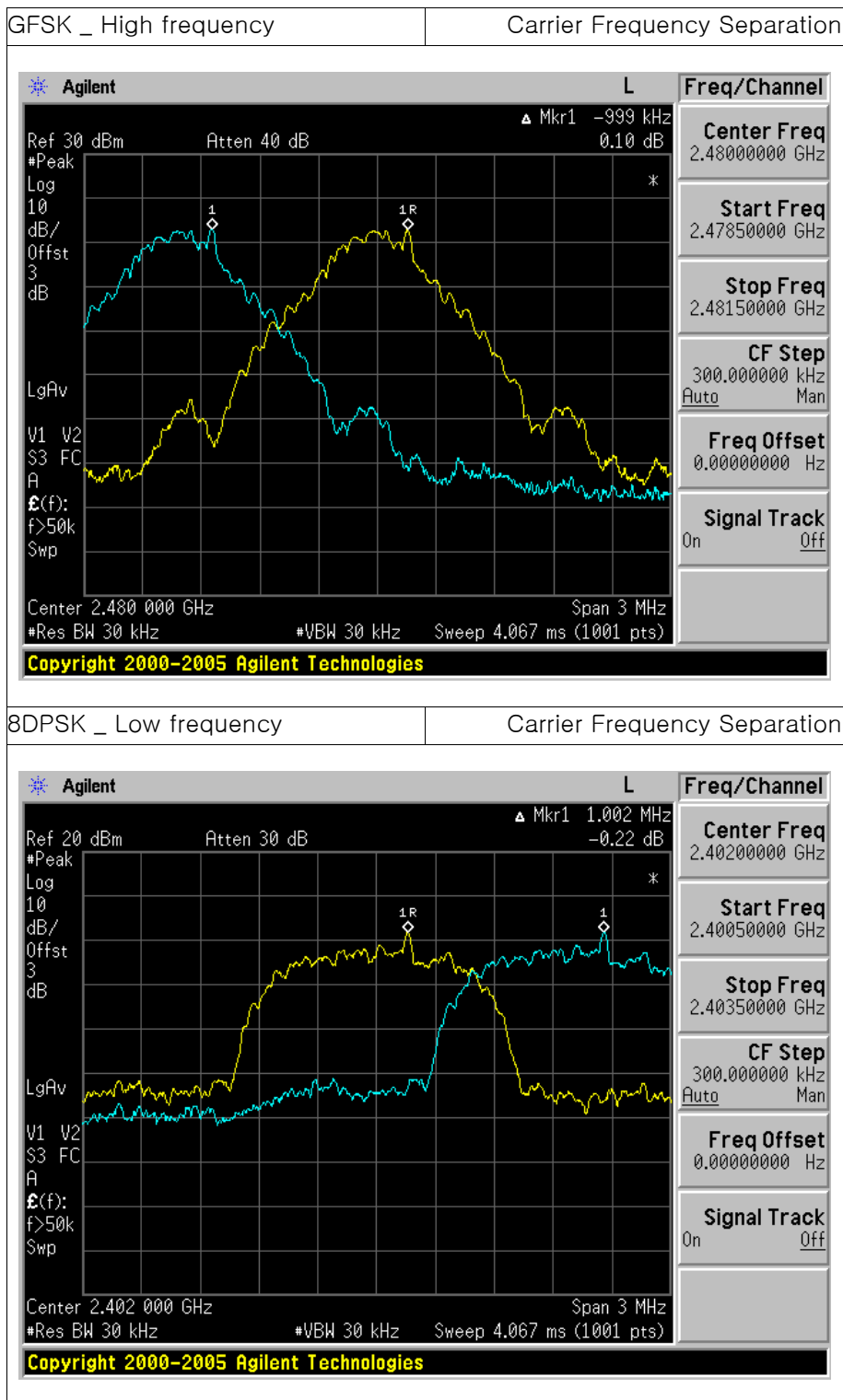
9.4 Test Result

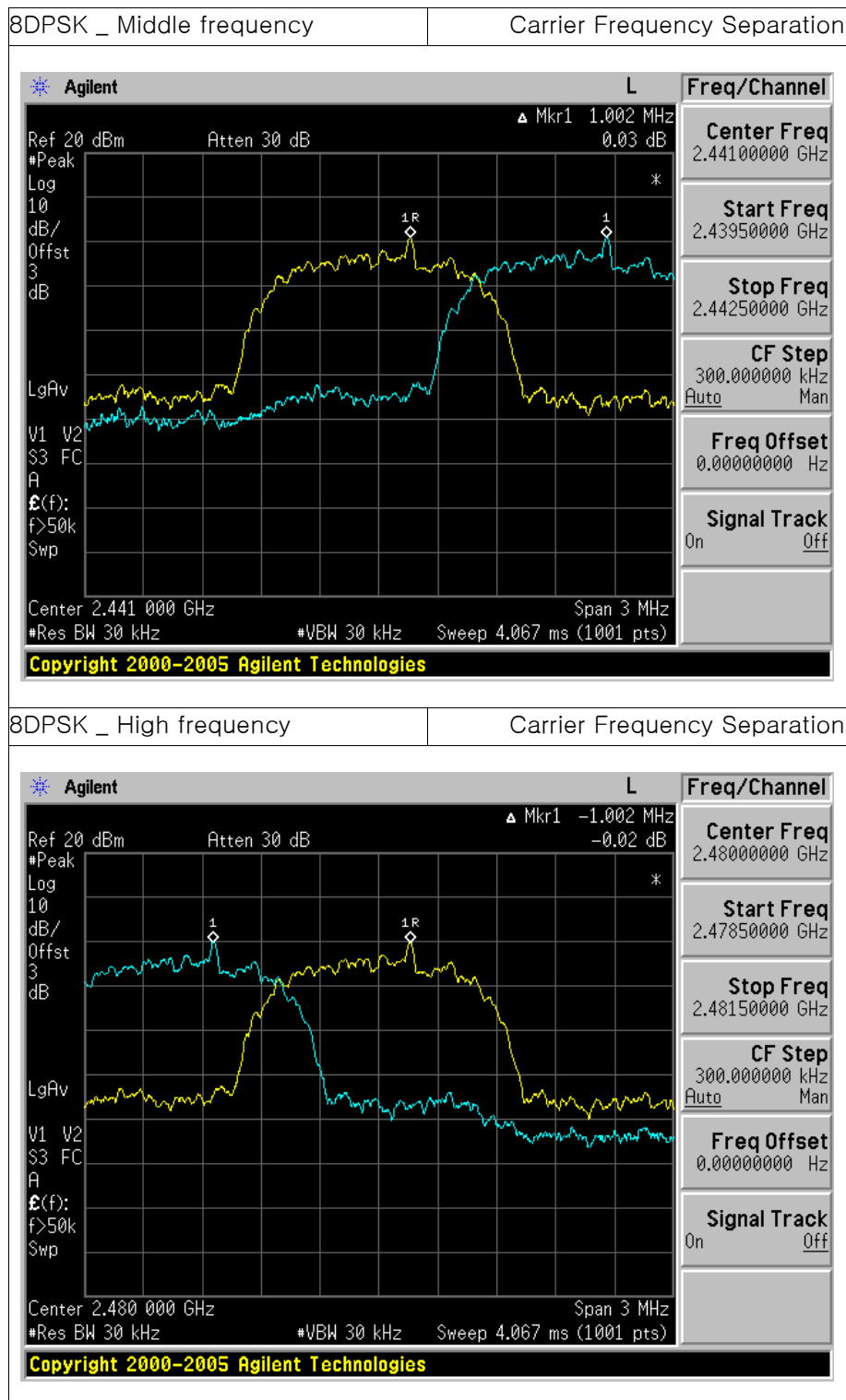
Test Mode	Test Frequency	Carrier Frequencies Separation (MHz)	Min. Limit (MHz)
GFSK	Low	1.002	0.641
	Middle	0.999	0.641
	High	0.999	0.640
8DPSK	Low	1.002	0.875
	Middle	1.002	0.877
	High	1.002	0.875

Note: Limit(kHz) = Test Result of 20 dB BW * 2/3

9.5 Test Plot









10. Peak Output Power

10.1 Test Setup

Refer to the APPENDIX I.

10.2 Limit

■ FCC Requirements

The maximum peak output power of the intentional radiator shall not exceed the following:

1. §15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400–2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
2. §15.247(b)(1), For frequency hopping systems operating in the 2400 – 2483.5 MHz employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725 – 5805 MHz band: 1 Watt. For all other frequency hopping systems in the 2400–2483.5 MHz band: 0.125 watts.

■ IC Requirements

1. RSS-247(5.4) (b), For FHSS operating in the band 2400 – 2483.5 MHz, the maximum peak conducted output power shall not exceed 1.0 W if the hopset uses 75 or more hopping channels, the maximum peak conducted output power shall not exceed 0.125 W if the hopset uses less than 75 hopping channels. The e.i.r.p shall not exceed 4 W, except as provided in section 5.4(e)

10.3 Test Procedure

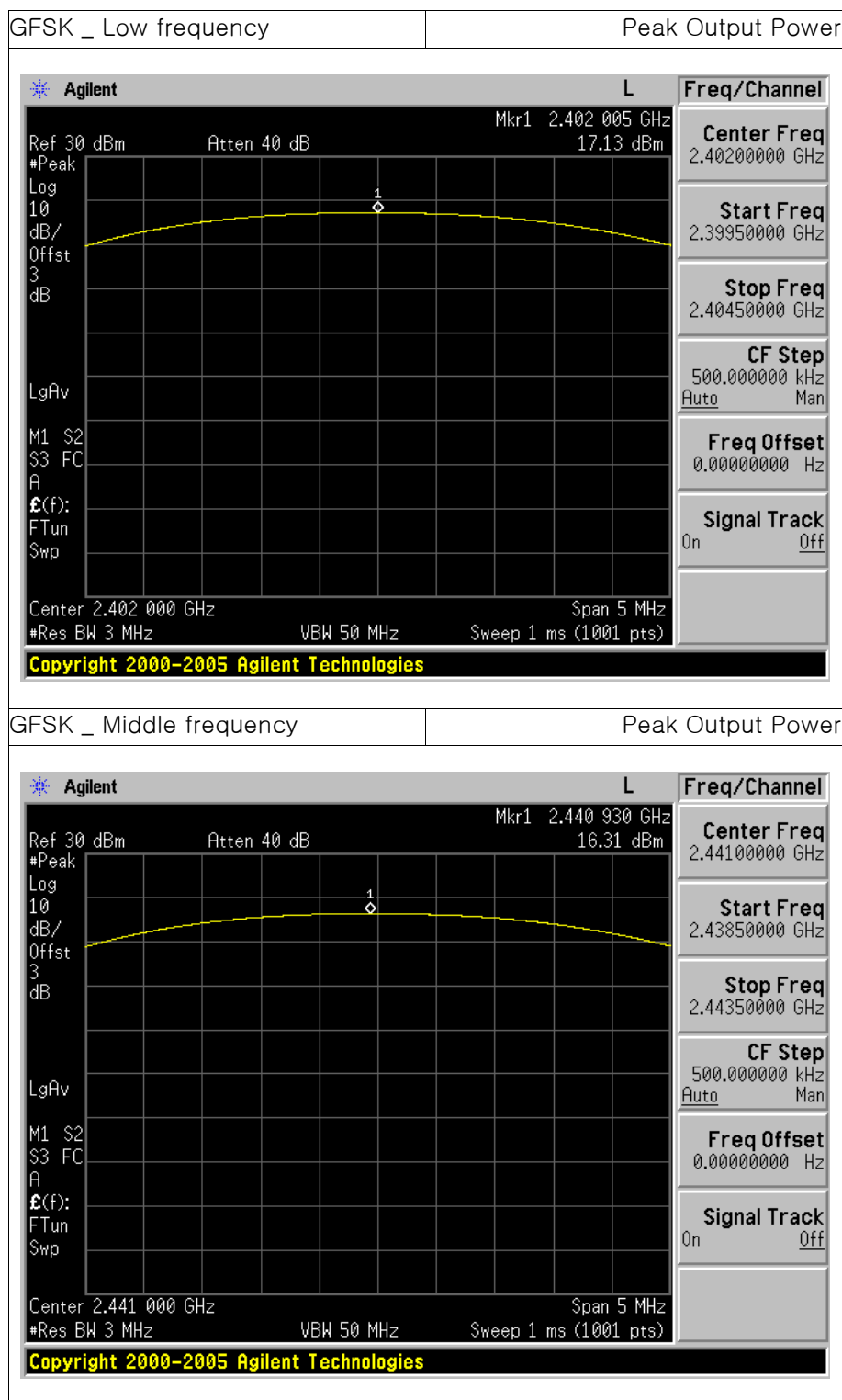
1. The RF output power was measured with a spectrum analyzer connected to the RF Antenna connector (conducted measurement) while EUT was operating in transmit mode at the appropriate center frequency, a spectrum analyzer was used to record the shape of the transmit signal.
2. The peak output power of the fundamental frequency was measured with the spectrum analyzer using:
 - Span = approximately 5 times of the 20 dB bandwidth, centered on a hopping channel
 - RBW $\geq$ 20 dB Bandwidth
 - VBW $\geq$ RBW
 - Sweep = Auto
 - Detector function = Peak
 - Trace = Max Hold

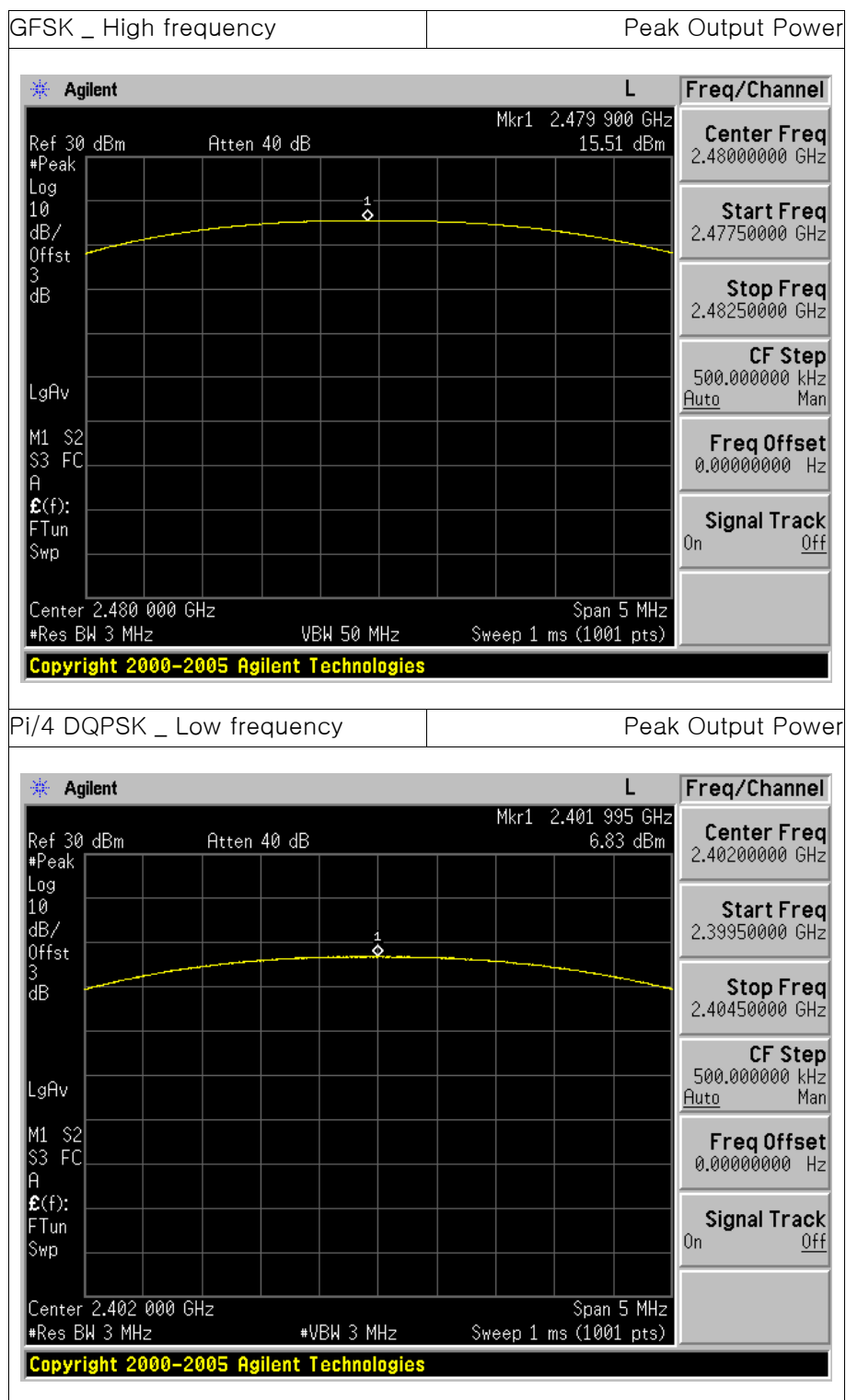


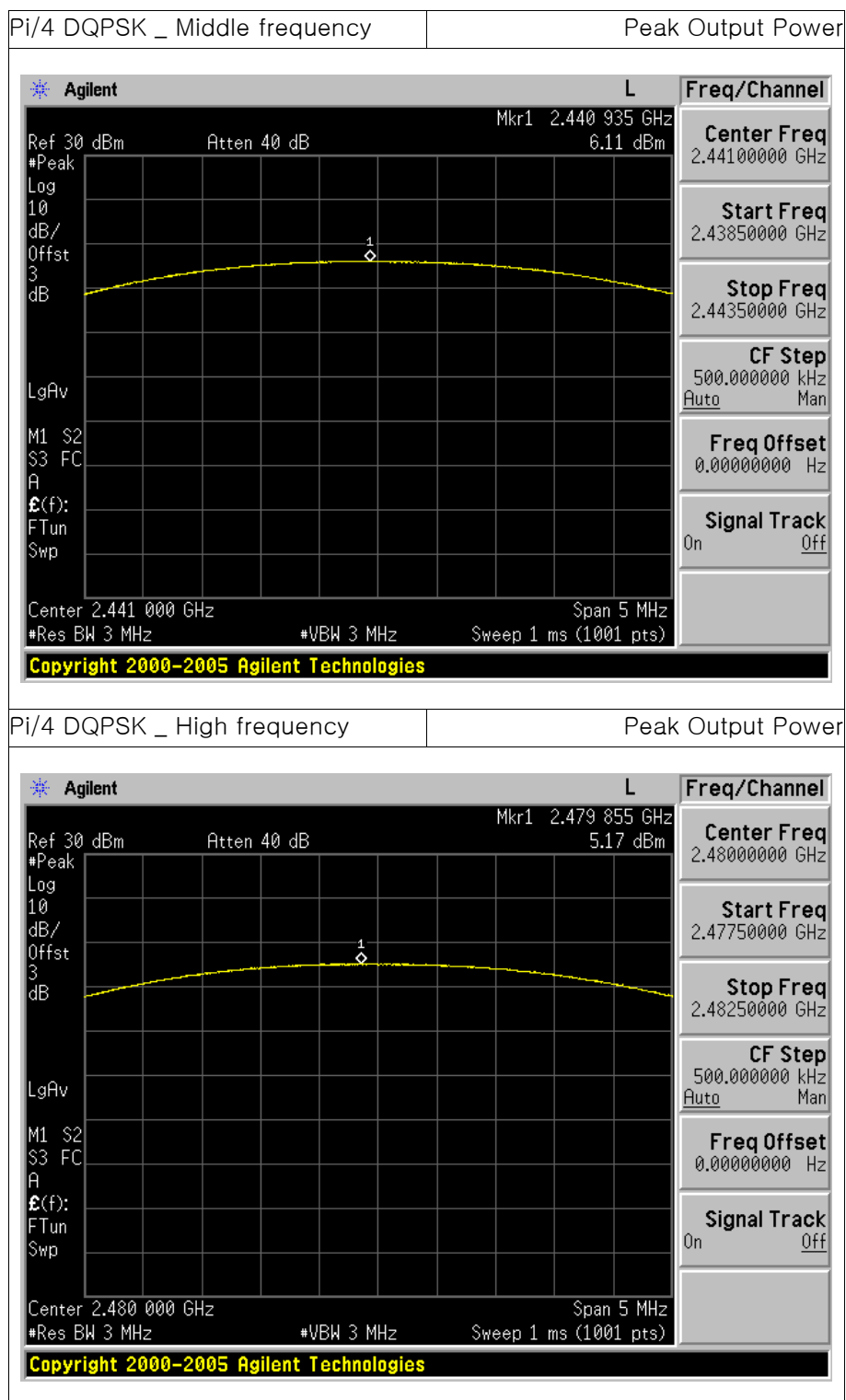
10.4 Test Result

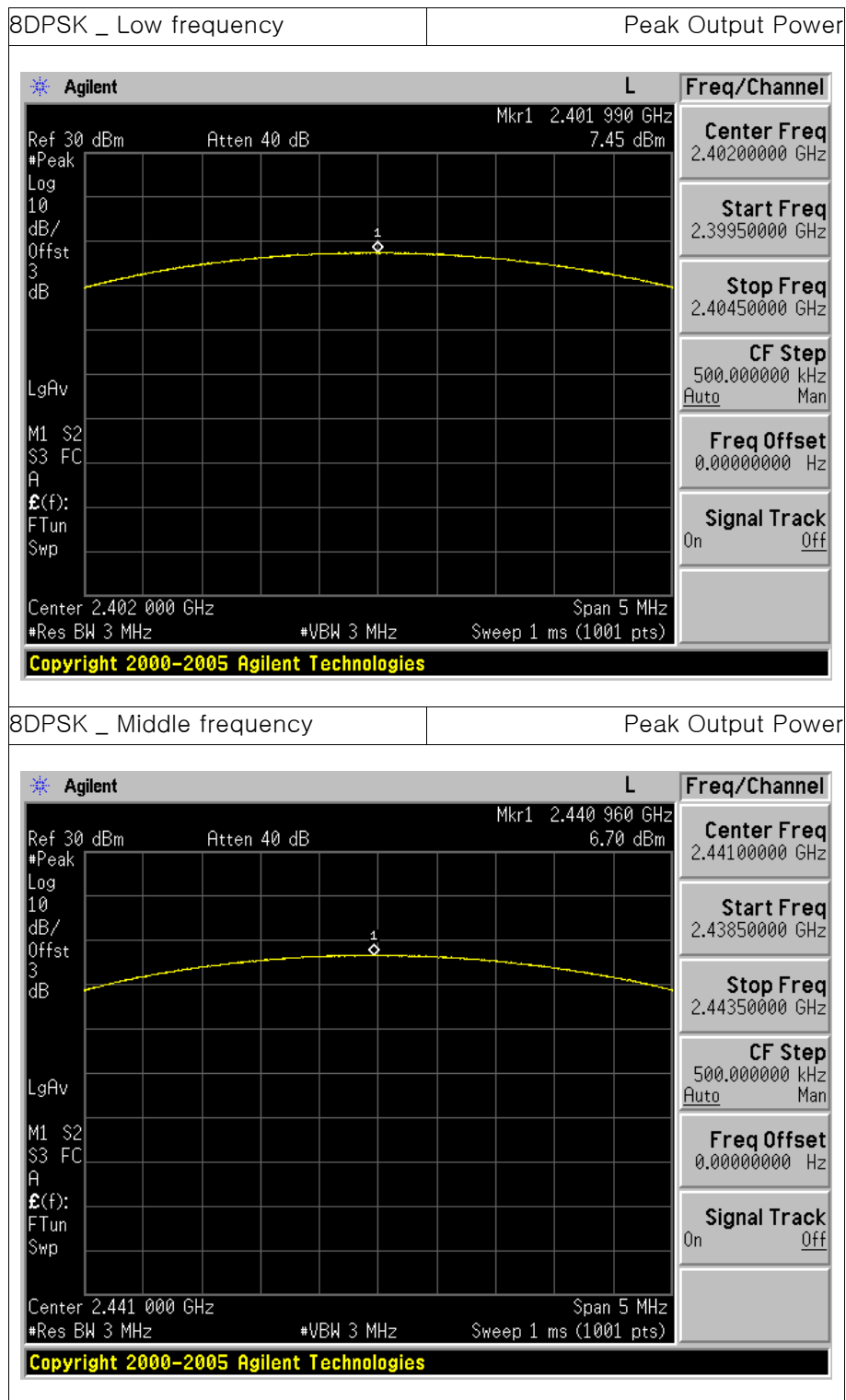
Test Mode	Test Frequency	Peak Output Power	
		dBm	mW
GFSK	Low	17.13	51.64
	Middle	16.31	42.76
	High	15.51	35.56
Pi/4 DQPSK	Low	6.83	4.82
	Middle	6.11	4.08
	High	5.17	3.29
8DPSK	Low	7.45	5.56
	Middle	6.70	4.68
	High	5.74	3.75

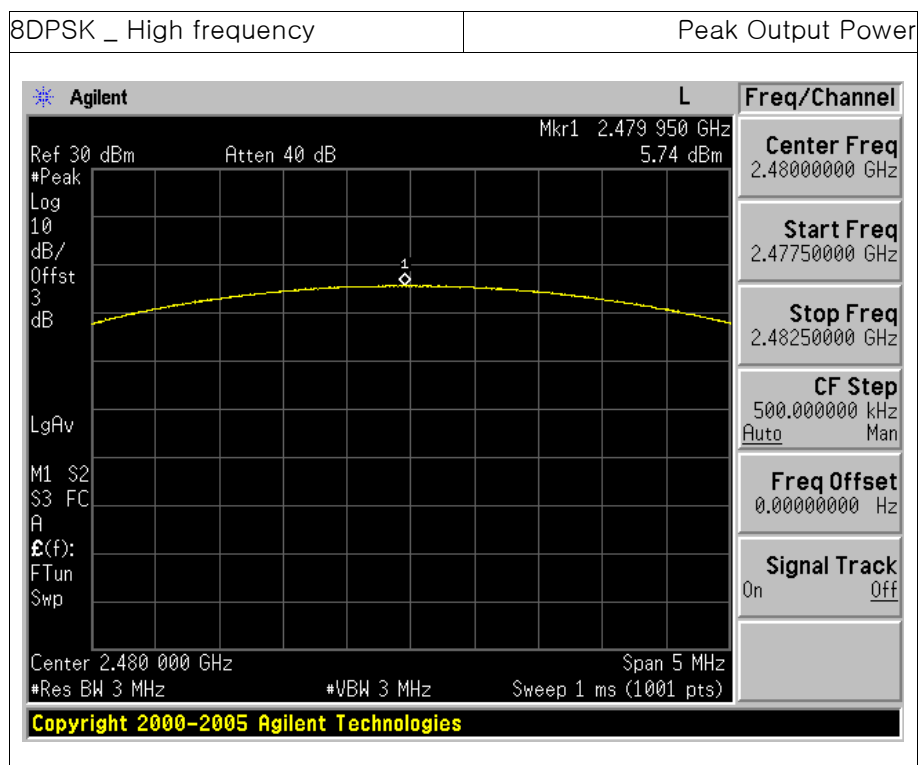
10.5 Test Plot











11. TX Radiated Spurious Emission and Conducted Spurious Emission

11.1 Test Setup

Refer to the APPENDIX I.

11.2 Limit

According to §15.247(d), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph(b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in section §15.209(a) is not required. In addition, radiated emission which in the restricted band, as define in section §15.205(a), must also comply the radiated emission limits specified in section §15.209(a) (see section §15.205(c))

According to § 15.209(a), except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table

Frequency (MHz)	Limit (uV/m)	Measurement Distance (meter)
0.009 ~ 0.490	2400/F (kHz)	300
0.490 ~ 1705	24000/F (kHz)	30
1705 ~ 30.0	30	30
30 ~ 88	100 **	3
88 ~ 216	150 **	3
216 ~ 960	200 **	3
Above 960	500	3

** Except as provided in 15.209(g), fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54 – 72 MHz, 76 – 88 MHz, 174 – 216 MHz or 470 – 806 MHz. However, operation within these frequency bands is permitted under other sections of this Part, e.g. 15.231 and 15.241.



According to § 15.205(a) and (b), only spurious emissions are permitted in any of
The frequency bands listed below:

MHz	MHz	MHz	GHz
0.009 ~ 0.110	16.42 ~ 16.423	399.90 ~ 410	4.5 ~ 5.15
0.495 ~ 0.505	16.69475 ~ 16.69525	608 ~ 614	5.35 ~ 5.46
2.1735 ~ 2.1905	16.80425 ~ 16.80475	960 ~ 1240	7.25 ~ 7.75
4.125 ~ 4.128	25.5 ~ 25.67	1300 ~ 1427	8.025 ~ 8.5
4.17725 ~ 4.17775	37.5 ~ 38.	1435 ~ 1626.5	9.0 ~ 9.2
4.20725 ~ 4.20775	25.73 ~ 74.6	1645.5 ~ 1646.5	9.3 ~ 9.5
4.17725 ~ 4.17775	74.8 ~ 75.2	1660 ~ 1710	10.6 ~ 12.7
6.215 ~ 6.218	108 ~ 121.94	1718.8 ~ 1722.2	13.25 ~ 13.4
6.26775 ~ 6.26825	149.9 ~ 150.05	2200 ~ 2300	14.47 ~ 14.5
6.31175 ~ 6.31225	156.52475 ~ 156.52525	2310 ~ 2390	15.35 ~ 16.2
8.291 ~ 8.294	156.7 ~ 156.9	2483.5 ~ 2500	17.7 ~ 21.4
8.362 ~ 8.366	162.0125 ~ 167.17	2690 ~ 2900	22.01 ~ 23.12
8.37625 ~ 8.38675	3345.8 ~ 3358	3260 ~ 3267	23.6 ~ 24.0
8.41425 ~ 8.41475	3600 ~ 4400	3332 ~ 3339	31.2 ~ 31.8
12.51975 ~ 12.52025	3345.8 ~ 3358	240 ~ 285	36.43 ~ 36.5
12.57675 ~ 12.57725	3600 ~ 4400	322 ~ 335.4	Above 38.6
13.36 ~ 13.41			

The field strength of emissions appearing within these frequency bands shall not exceed the limits shown in §15.209. At frequencies equal to or less than 1000 MHz, compliance with the limits in §15.209 shall be demonstrated using measurement instrumentation employing a CISPR quasi-peak detector. Above 1000 MHz, compliance with the emission limits in §15.209 shall be demonstrated based on the average value of the measured emissions. The provisions in §15.35 apply to these measurements.

11.3 Test Procedure for Radiated Spurious Emission

1. The EUT is placed on a non-conductive table. For emission measurements at or below 1 GHz, the table height is 80 cm. For emission measurements above 1 GHz, the table height is 1.5 m. The table was rotated 360 degrees to determine the position of the highest radiation.
2. During performing radiated emission below 1 GHz, the EUT was set 3 meters away from the interference receiving antenna, which was mounted on the top of a variable-height antenna tower. During performing radiated emission above 1 GHz, the EUT was set 3.75 meter away from the interference-receiving antenna.
3. For measurements above 1 GHz absorbers are placed on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1 GHz, the absorbers are removed.
4. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
5. For each suspected emission, the EUT was arranged to its worst case and then The antenna was tuned to heights from 1 meter to 4 meters and the table was turned from 0 degrees to 360 degrees to find the maximum reading.
(The EUT was pre-tested with three axes (X, Y, Z) and the final test was performed at the worst case.)
6. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
7. If the emission level of the EUT in peak mode was 10 dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10 dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

Measurement Instrument Setting

1. Frequency Range: Below 1 GHz
RBW = 100 or 120 kHz, VBW = 3 x RBW, Detector = Peak or Quasi Peak
2. Frequency Range: Above 1 GHz
Peak Measurement
RBW = 1 MHz, VBW = 3 MHz, Detector = Peak, Sweep time = Auto,
Trace mode = Max Hold until the trace stabilizes

Average Measurement
RBW = 1MHz, VBW $\geq 1/T$, Detector = Peak, Sweep Time = Auto,
Trace Mode = Max Hold until the trace stabilizes

11.4 Test Procedure for Conducted Spurious Emission

1. The transmitter output was connected to the spectrum analyzer.
2. The reference level of the fundamental frequency was measured with the spectrum analyzer using
RBW = 100 kHz, VBW = 300 kHz.
3. The conducted spurious emission was tested each ranges were set as below.
Frequency range: 30 MHz ~ 26.5 GHz
RBW = 100 kHz, VBW = 300 kHz, Sweep Time = Auto, Detector = Peak,
Trace = Max Hold

LIMIT LINE = 20 dB below of the reference level of above measurement procedure
Step 2. (RBW = 100 kHz, VBW = 300 kHz)

11.5 Test Result

9 kHz ~ 25 GHz Data (Modulation: GFSK)

● Low frequency

Frequency	Reading		Pol.	T.F (dB)	DCCF (dB)	Limits		Result		Margin	
	(dBuV/m)					(dBuV/m)		(dBuV/m)		(dB)	
(MHz)	AV / Peak					AV / Peak		AV / Peak		AV / Peak	
2 389.64	N/A	48.28	V	11.19	-24.77	54.0	74.0	34.7	59.5	19.3	14.5
4 804.30	N/A	56.70	V	-0.36	-24.77	54.0	74.0	31.6	56.3	22.4	17.7
7 205.98	N/A	51.72	V	9.74	-24.77	54.0	74.0	36.7	61.5	17.3	12.5
9 608.10	N/A	42.88	V	13.31	-24.77	54.0	74.0	31.4	56.2	22.6	17.8
12 010.76	N/A	36.71	V	19.68	-24.77	54.0	74.0	31.6	56.4	22.4	17.6

● Middle frequency

Frequency	Reading		Pol.	T.F (dB)	DCCF (dB)	Limits		Result		Margin	
	(dBuV/m)					(dBuV/m)		(dBuV/m)		(dB)	
(MHz)	AV / Peak					AV / Peak		AV / Peak		AV / Peak	
4 882.27	N/A	51.84	V	-0.31	-24.77	54.0	74.0	26.8	51.5	27.2	22.5
7 323.46	N/A	55.91	V	9.75	-24.77	54.0	74.0	40.9	65.7	13.1	8.3
9 764.11	N/A	44.39	V	13.86	-24.77	54.0	74.0	33.5	58.3	20.5	15.8
12 203.99	N/A	36.92	V	19.86	-24.77	54.0	74.0	32.0	56.8	22.0	17.2

● High frequency

Frequency	Reading		Pol.	T.F (dB)	DCCF (dB)	Limits		Result		Margin	
	(dBuV/m)					(dBuV/m)		(dBuV/m)		(dB)	
(MHz)	AV / Peak					AV / Peak		AV / Peak		AV / Peak	
2 483.51	N/A	58.65	V	10.93	−24.77	54.0	74.0	44.8	69.6	9.2	4.4
4 960.28	N/A	51.45	V	−0.37	−24.77	54.0	74.0	26.3	51.1	27.7	22.9
7 440.45	N/A	56.46	V	9.90	−24.77	54.0	74.0	41.6	66.4	12.4	7.6
9 919.75	N/A	45.40	V	14.03	−24.77	54.0	74.0	34.7	59.4	19.3	14.6
12 400.73	N/A	35.89	V	19.20	−24.77	54.0	74.0	30.3	55.1	23.7	18.9

Note 1: The radiated emissions were investigated 9 kHz to 25 GHz. And no other spurious and harmonic emissions were found above listed frequencies.

Note 2: DCCF(Duty Cycle Correction Factor)

- Time to cycle through all channels = $\Delta t = T \text{ [ms]} \times 20$ minimum hopping channels, where $T = \text{pulse width} = 2.888 \text{ ms}$
- $100 \text{ ms} / \Delta t \text{ [ms]} = H \rightarrow$ Round up to next highest integer, to account for worst case, $H' = 100 / (2.888 \times 20) = 1.73 \approx 2$

- The Worst Case Dwell Time = $T \text{ [ms]} \times H' = 2.888 \text{ ms} \times 2 = 5.78 \text{ ms}$

- $\text{DCCF} = 20 \times \log(\text{The Worst Case Dwell Time} / 100 \text{ ms}) \text{ dB} = 20 \times \log(5.78 / 100) = -24.77 \text{ dB}$

Note 3: Sample Calculation.

Margin = Limit - Result / Peak Result = Peak Reading + TF / Average Result = Peak Reading + TF + DCCF

TF = Ant factor + Cable Loss + Filter Loss - Amp Gain + Distance Factor

Distance Factor = $20\log(\text{applied distance}/\text{required distance}) = 20\log(3.75\text{m}/3\text{m}) = 1.94$

9 kHz ~ 25 GHz Data (Modulation: 8DPSK)

● Low frequency

Frequency	Reading		Pol.	T.F (dB)	DCCF (dB)	Limits		Result		Margin	
	(dBuV/m)					(dBuV/m)		(dBuV/m)		(dB)	
	AV / Peak					AV / Peak		AV / Peak		AV / Peak	
(MHz)											
2 389.72	N/A	52.53	V	11.19	−24.78	54.0	74.0	38.9	63.7	15.1	10.3
4 803.96	N/A	59.26	V	−0.36	−24.78	54.0	74.0	34.1	58.9	19.9	15.1
7 206.49	N/A	52.85	V	9.74	−24.78	54.0	74.0	37.8	62.6	16.2	11.4
9 608.01	N/A	48.53	V	13.31	−24.78	54.0	74.0	37.1	61.8	16.9	12.2
12 009.13	N/A	36.80	V	19.68	−24.78	54.0	74.0	31.7	56.5	22.3	17.5

● Middle frequency

Frequency	Reading		Pol.	T.F (dB)	DCCF (dB)	Limits		Result		Margin	
	(dBuV/m)					(dBuV/m)		(dBuV/m)		(dB)	
	AV / Peak					AV / Peak		AV / Peak		AV / Peak	
4 881.86	N/A	54.52	V	−0.31	−24.78	54.0	74.0	29.4	54.2	24.6	19.8
7 323.06	N/A	55.80	V	9.75	−24.78	54.0	74.0	40.8	65.6	13.2	8.5
9 763.98	N/A	44.76	V	13.86	−24.78	54.0	74.0	33.8	58.6	20.2	15.4
12 204.80	N/A	36.48	V	19.86	−24.78	54.0	74.0	31.6	56.3	22.4	17.7

● High frequency

Frequency	Reading		Pol.	T.F (dB)	DCCF (dB)	Limits		Result		Margin	
	(dBuV/m)					(dBuV/m)		(dBuV/m)		(dB)	
	AV / Peak					AV / Peak		AV / Peak		AV / Peak	
2 483.51	N/A	59.51	V	10.93	-24.78	54.0	74.0	45.7	70.4	8.3	3.6
4 959.85	N/A	55.46	V	-0.37	-24.78	54.0	74.0	30.3	55.1	23.7	18.9
7 440.01	N/A	56.88	V	9.90	-24.78	54.0	74.0	42.0	66.8	12.0	7.2
9 919.80	N/A	45.30	V	14.03	-24.78	54.0	74.0	34.6	59.3	19.4	14.7
12 400.83	N/A	36.31	V	19.20	-24.78	54.0	74.0	30.7	55.5	23.3	18.5

Note 1: The radiated emissions were investigated 9 kHz to 25 GHz.

Note 2: DCCF(Duty Cycle Correction Factor)

- Time to cycle through all channels = $\Delta t = T \text{ [ms]} \times 20$ minimum hopping channels, where $T = \text{pulse width} = 2.884 \text{ ms}$
- $100 \text{ ms} / \Delta t \text{ [ms]} = H \rightarrow$ Round up to next highest integer, to account for worst case, $H' = 100 / (2.884 \times 20) = 1.73 \approx 2$
- The Worst Case Dwell Time = $T \text{ [ms]} \times H' = 2.884 \text{ ms} \times 2 = 5.77 \text{ ms}$
- $\text{DCCF} = 20 \times \log(\text{The Worst Case Dwell Time} / 100 \text{ ms}) \text{ dB} = 20 \times \log(5.77 / 100) = -24.78 \text{ dB}$

Note 3: Sample Calculation.

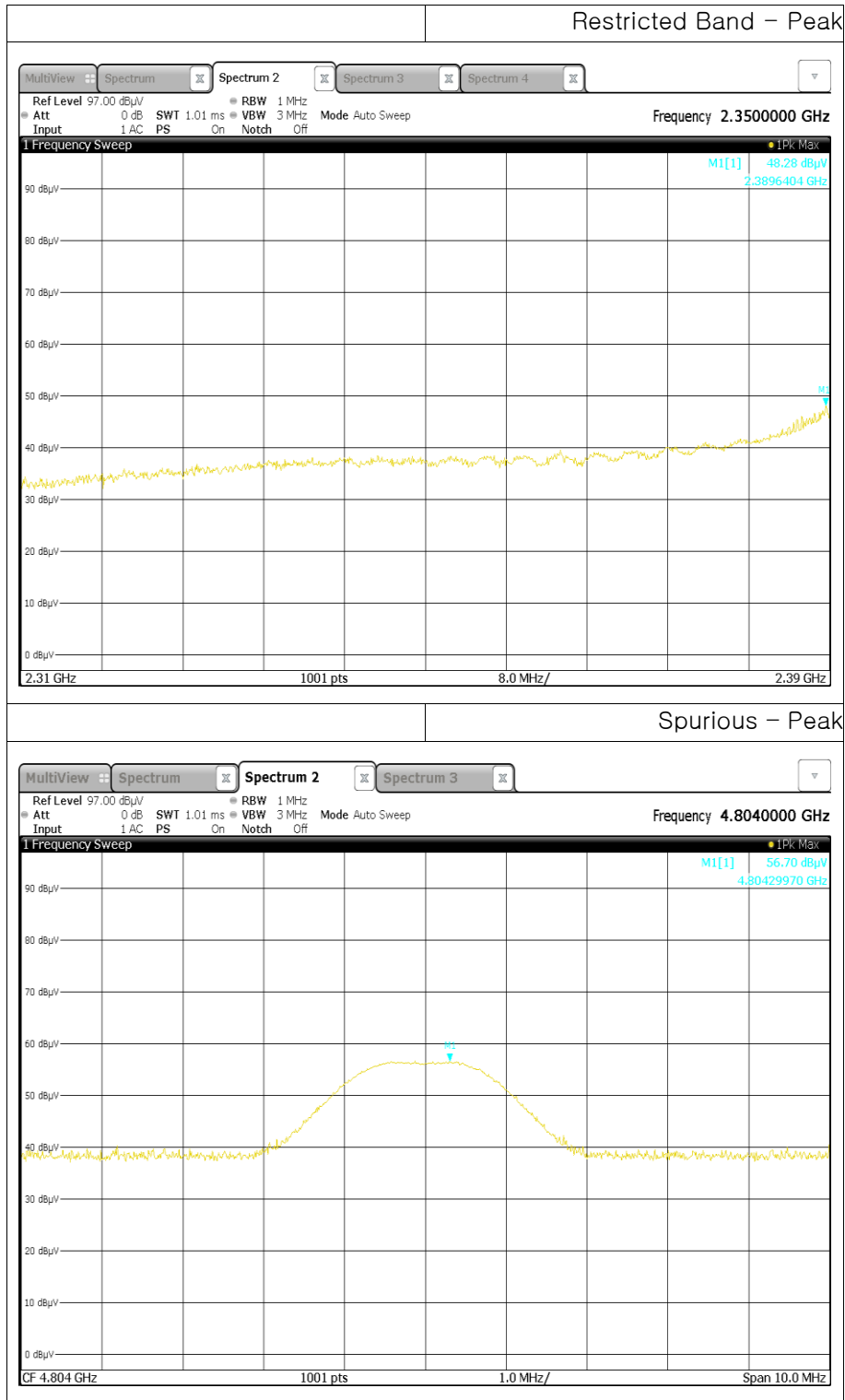
Margin = Limit - Result / Peak Result = Peak Reading + TF / Average Result = Peak Reading + TF + DCCF

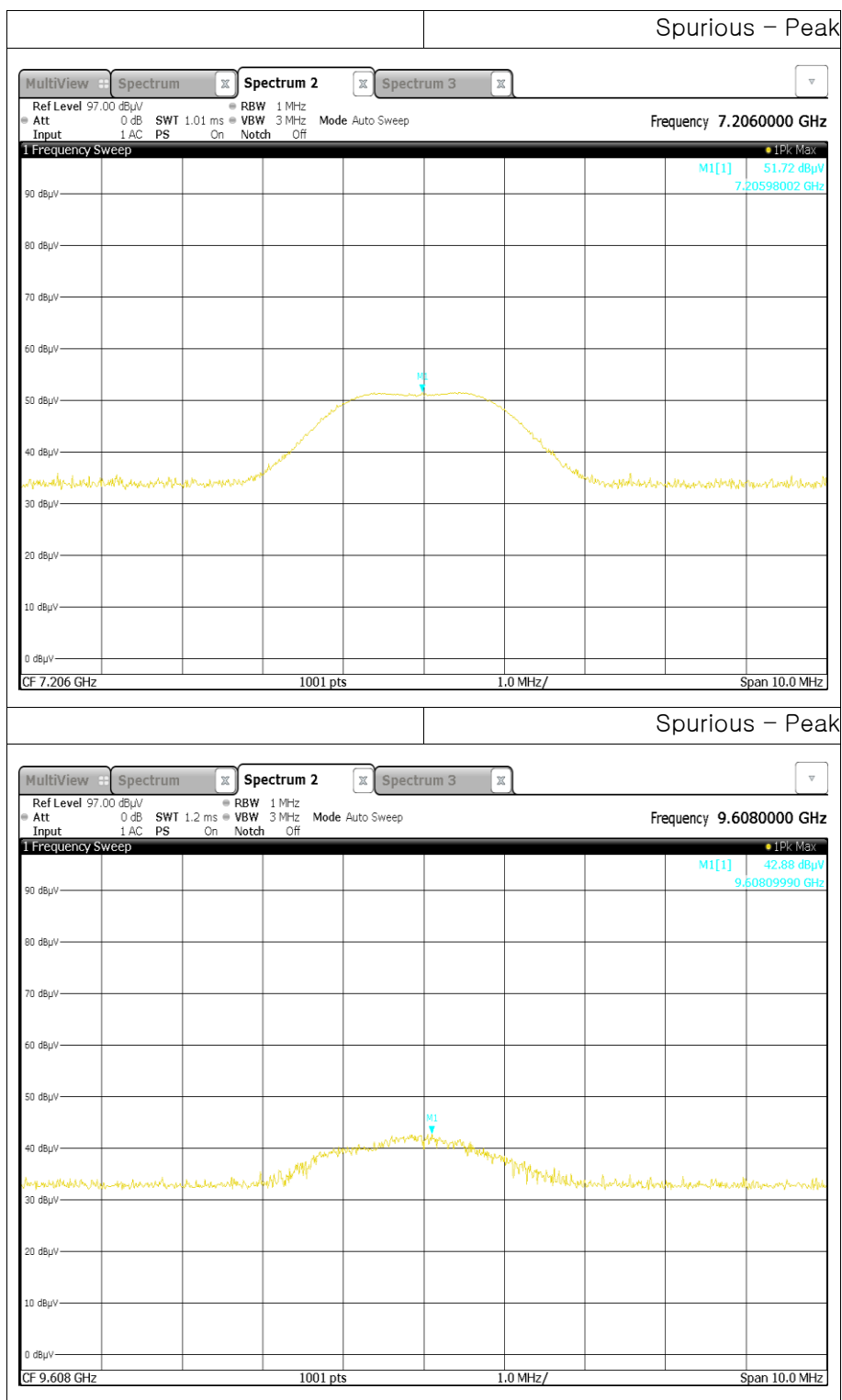
TF = Ant factor + Cable Loss + Filter Loss - Amp Gain + Distance Factor

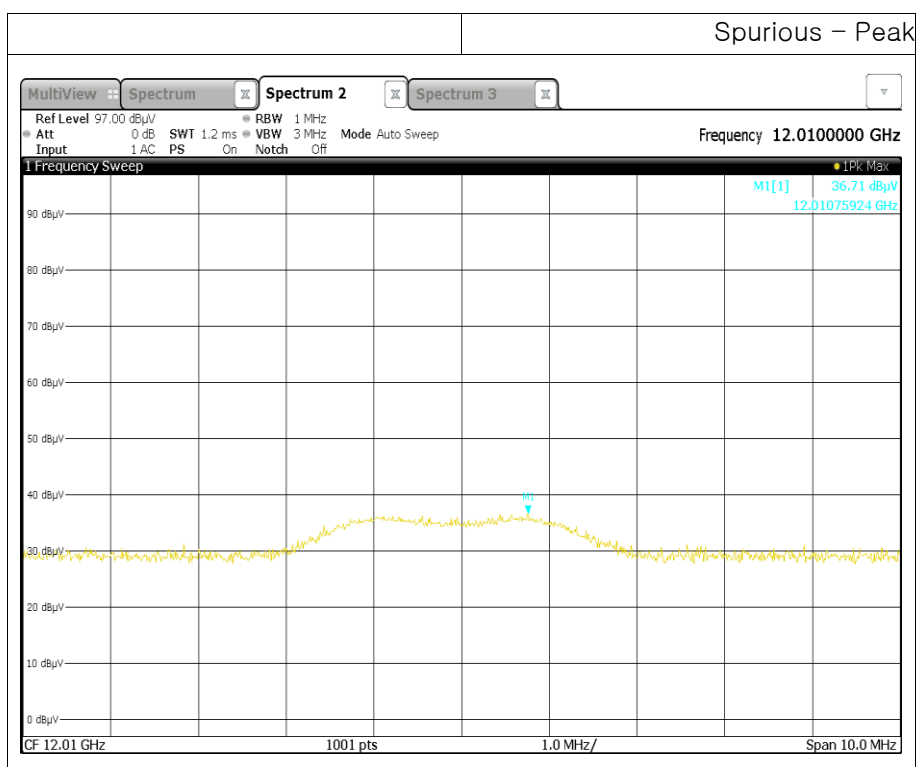
Distance Factor = $20\log(\text{applied distance}/\text{required distance}) = 20\log(3.75\text{m}/3\text{m}) = 1.94$

11.6 Test Plot for Radiated Spurious Emission

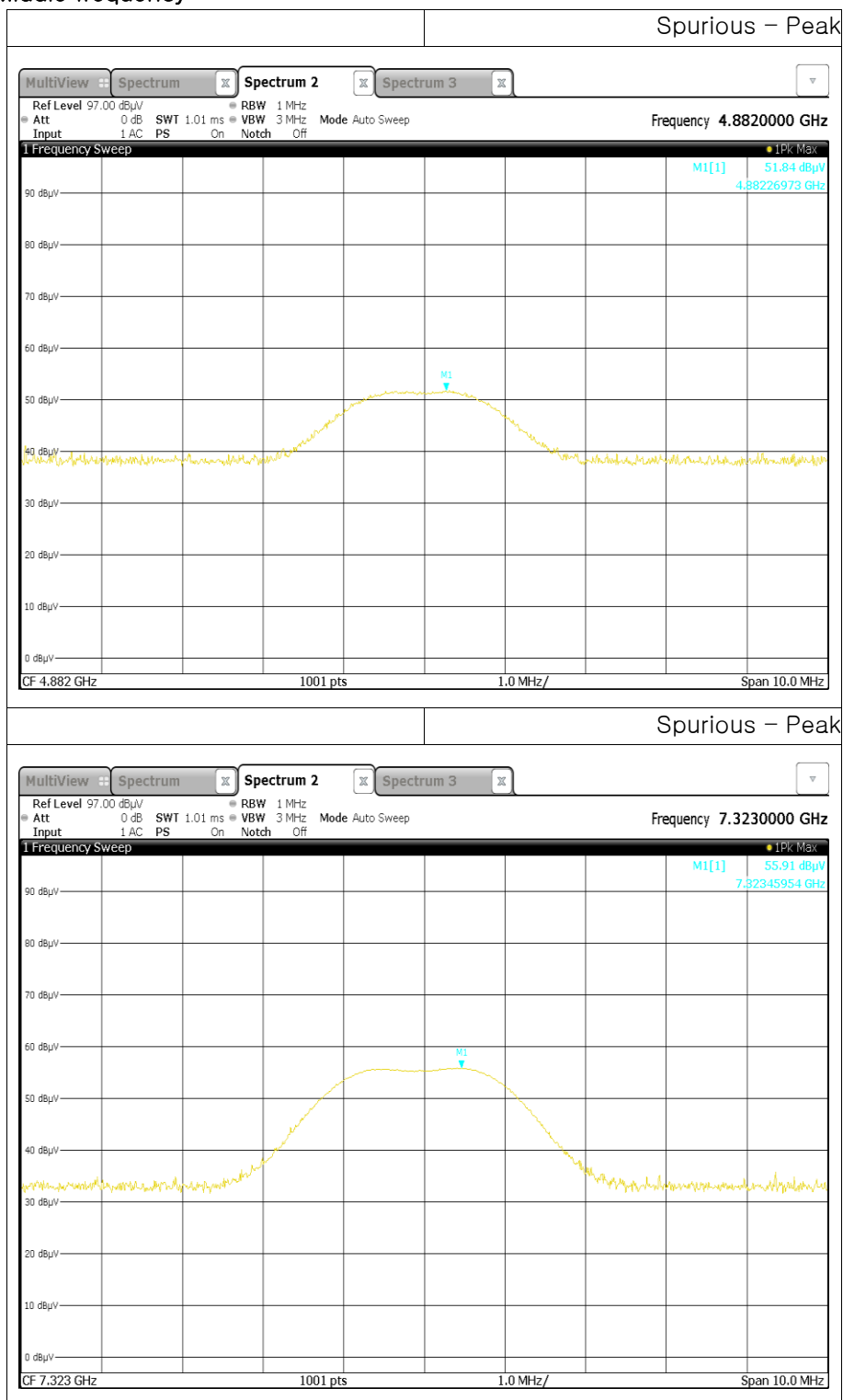
- GFSK _ Low frequency

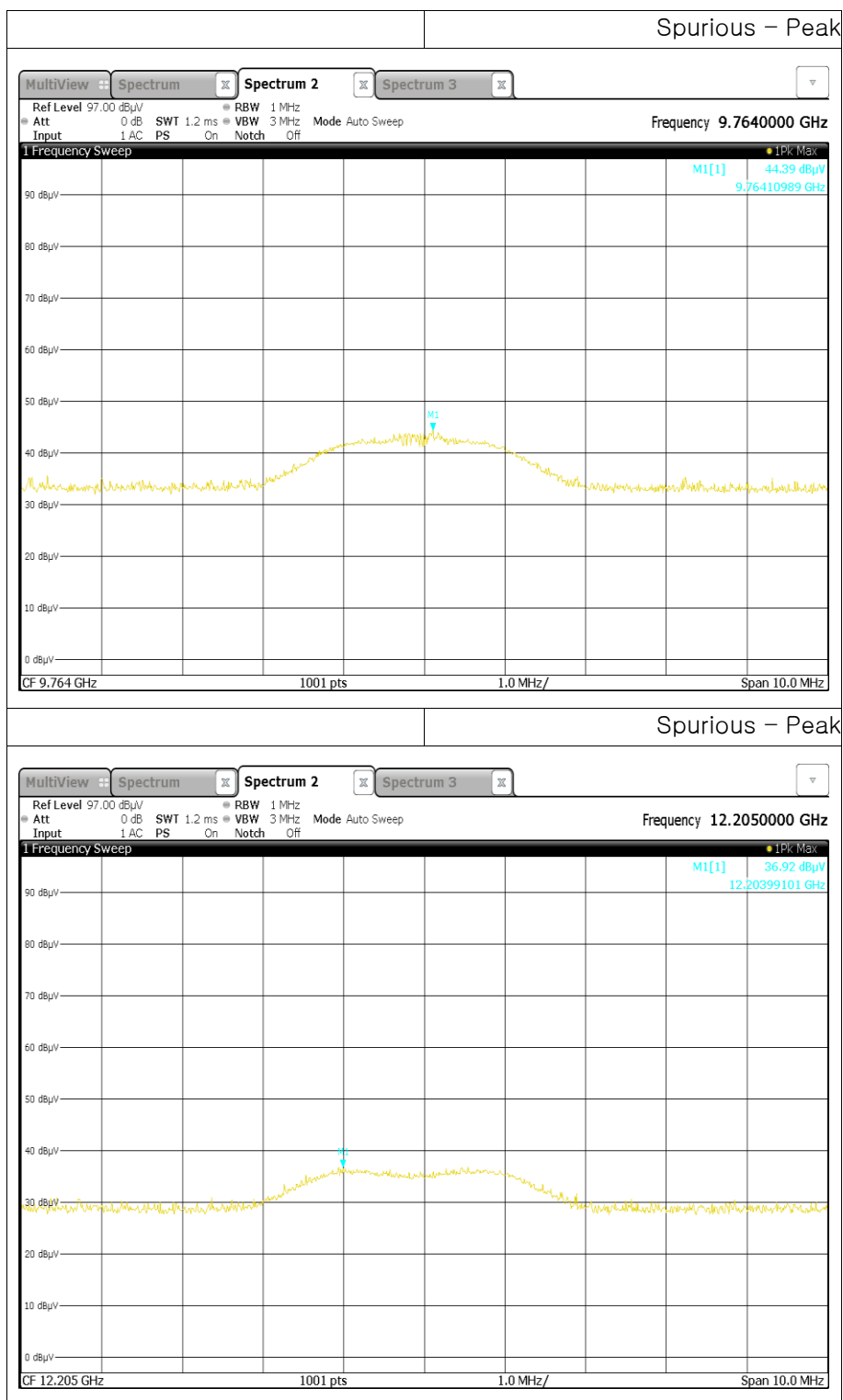




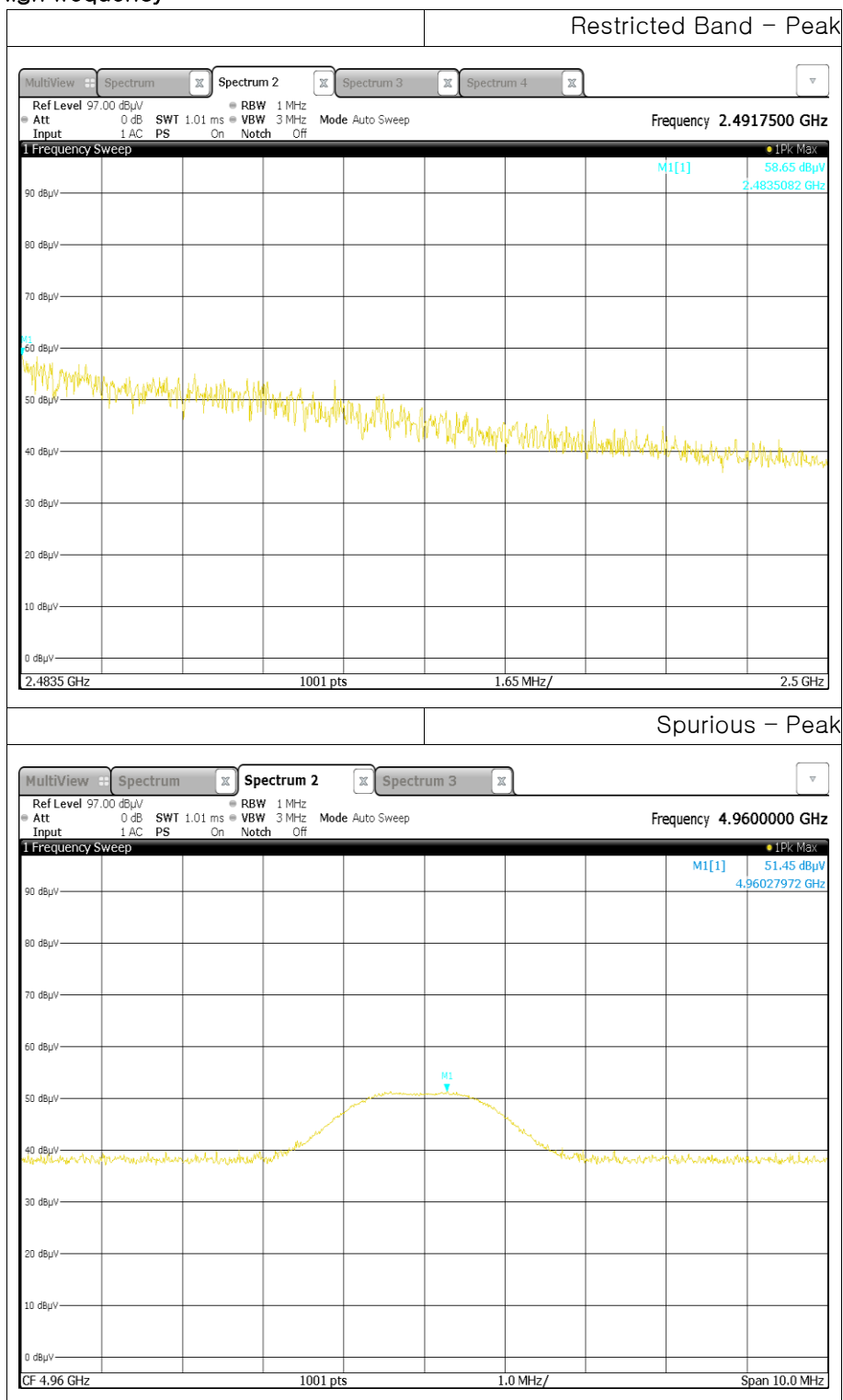


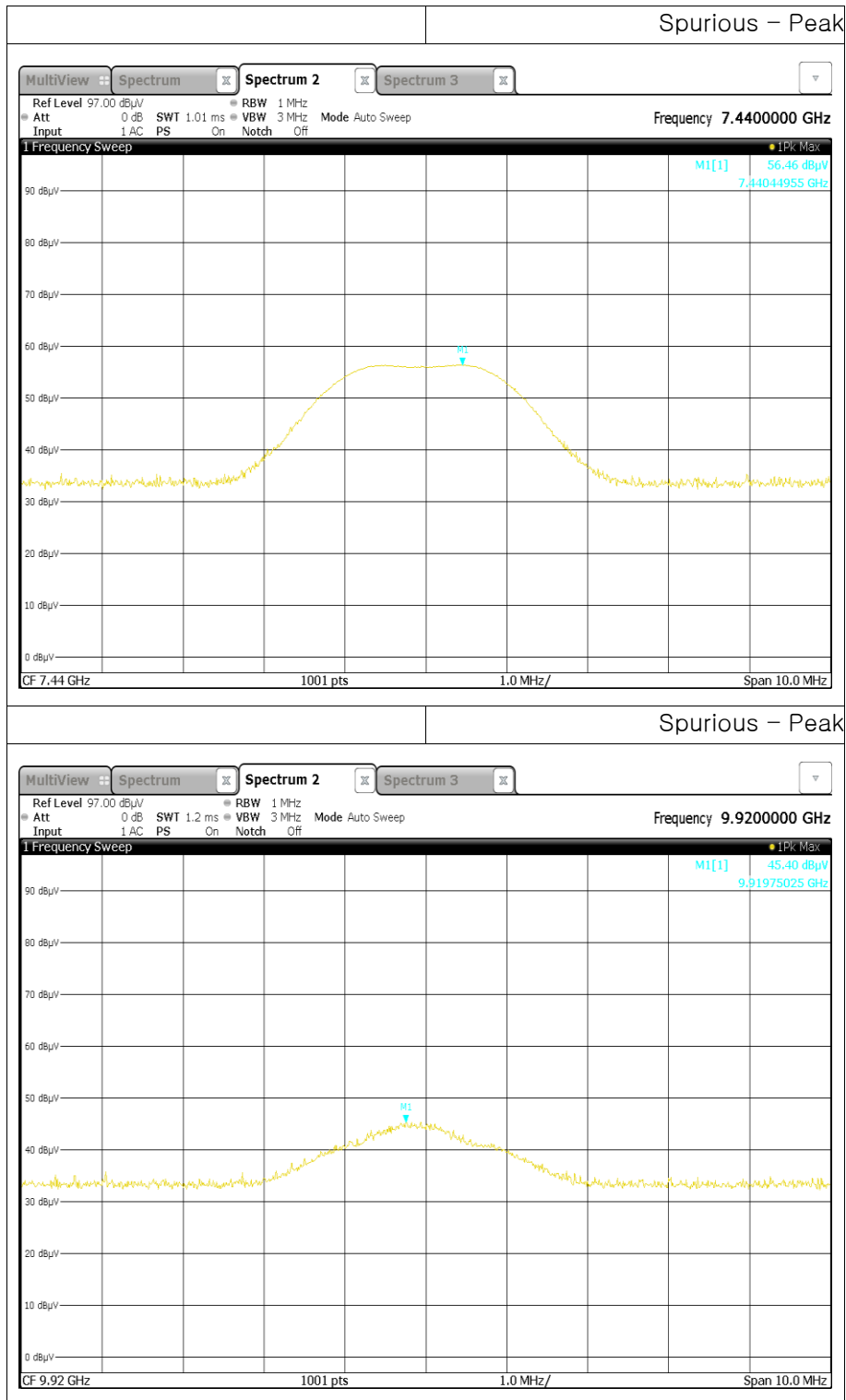
● GFSK _ Middle frequency

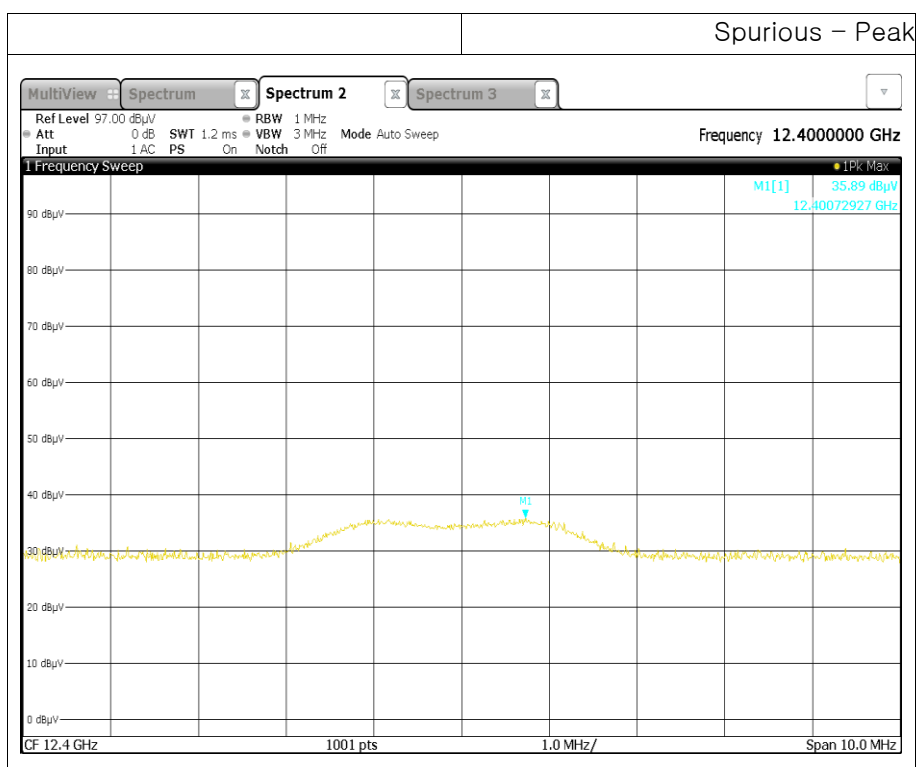




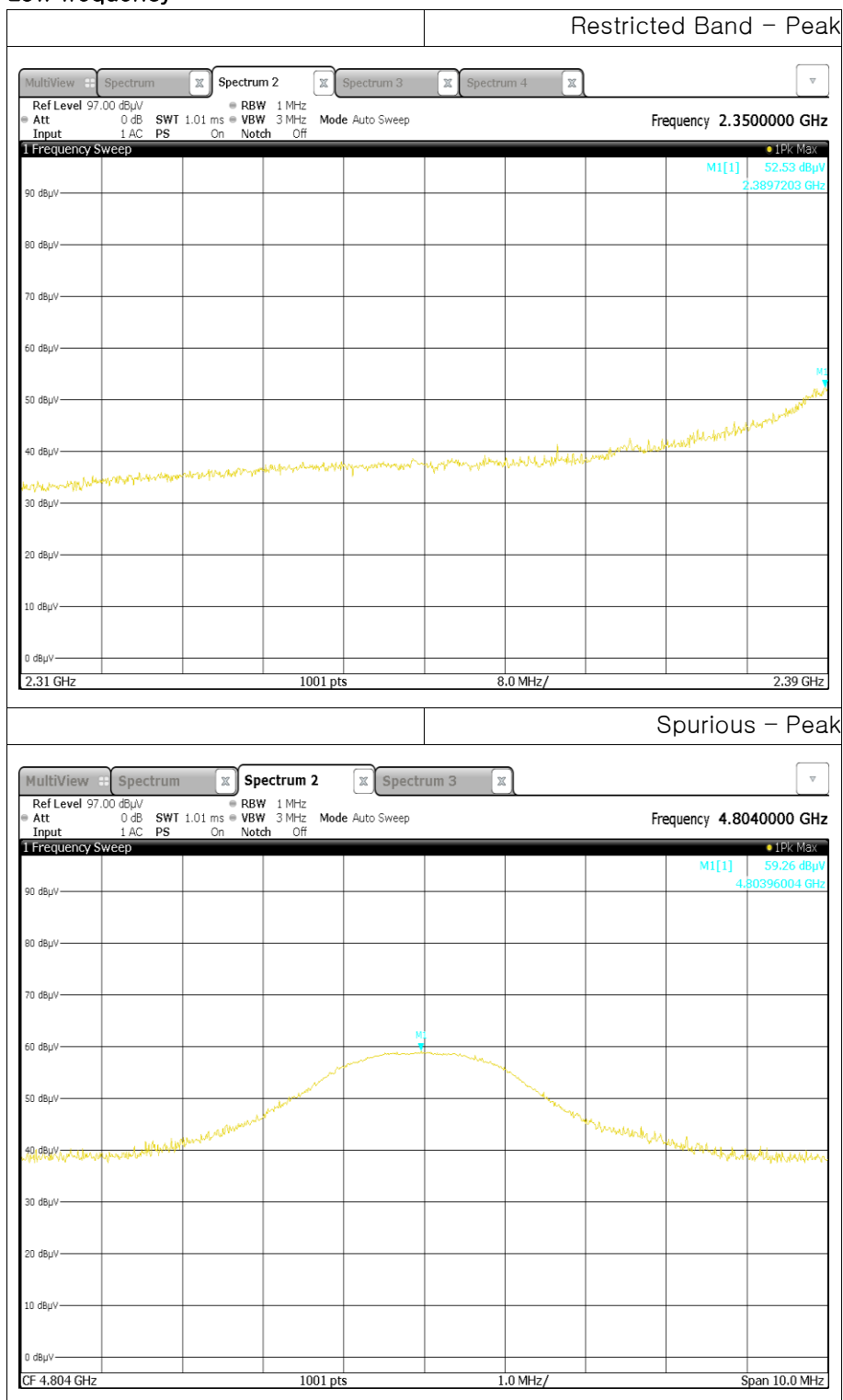
● GFSK _ High frequency

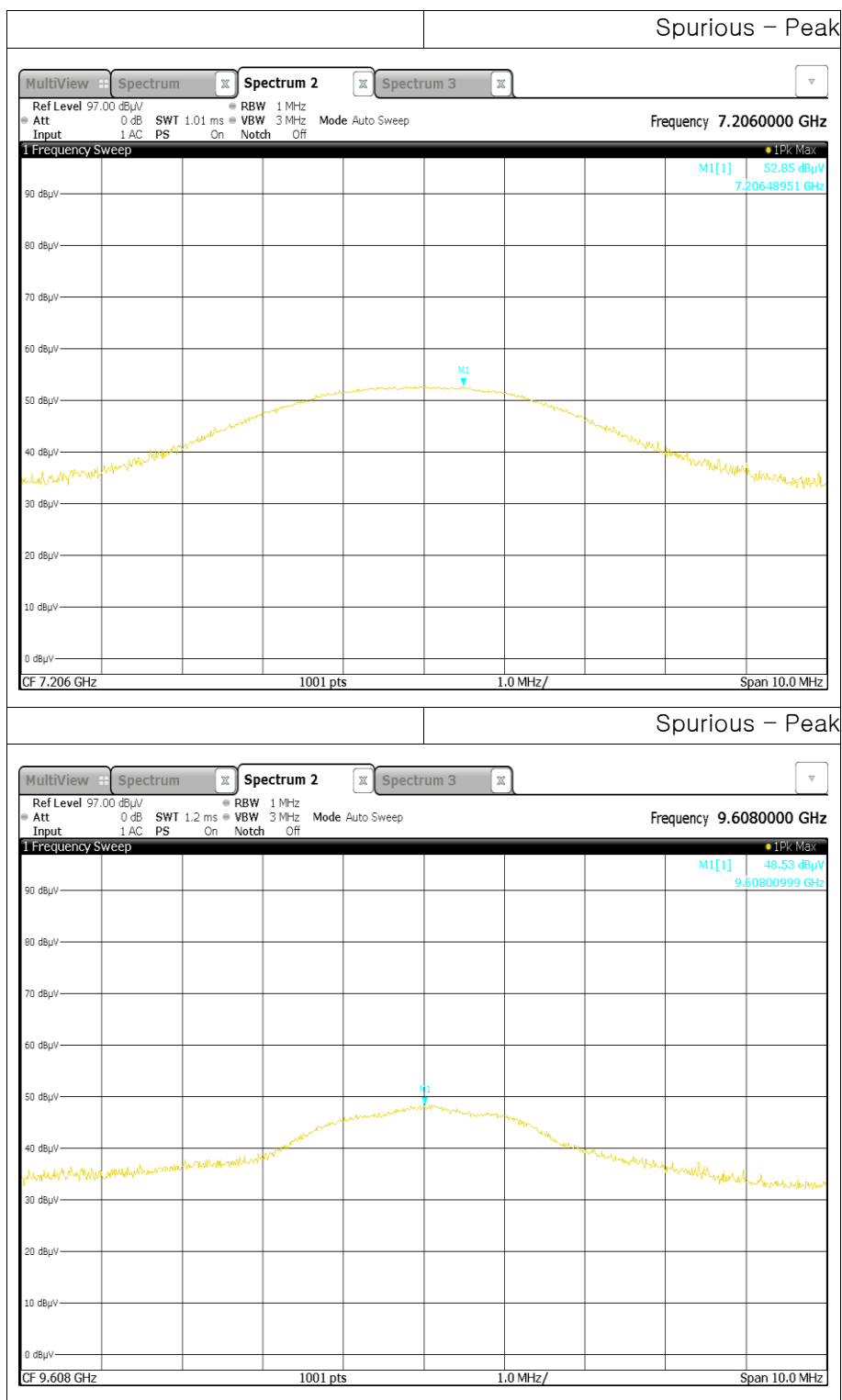


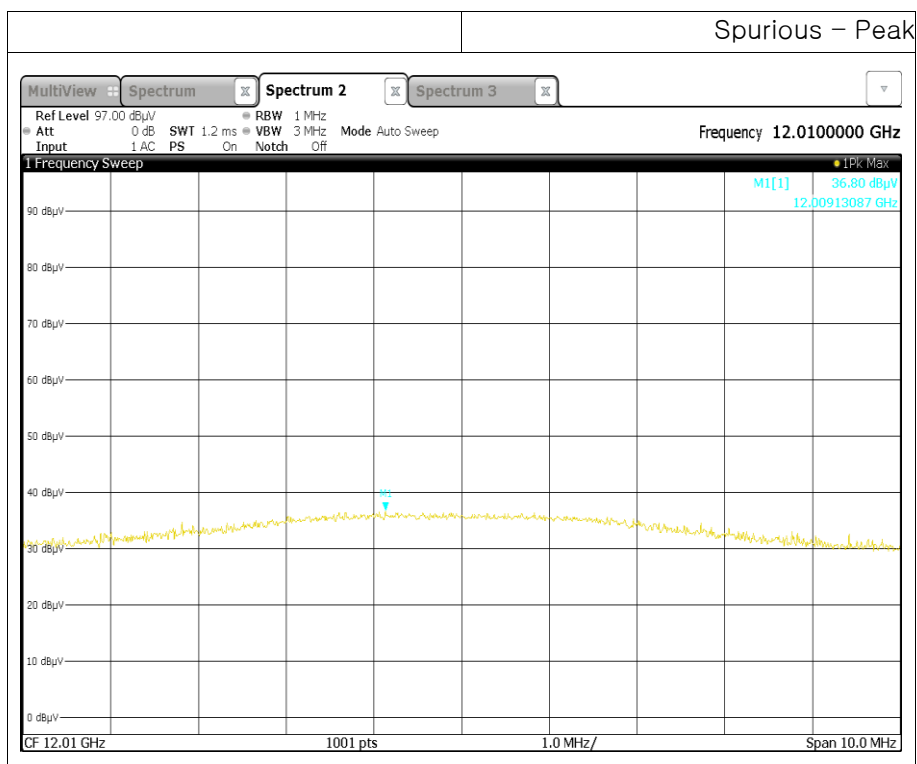




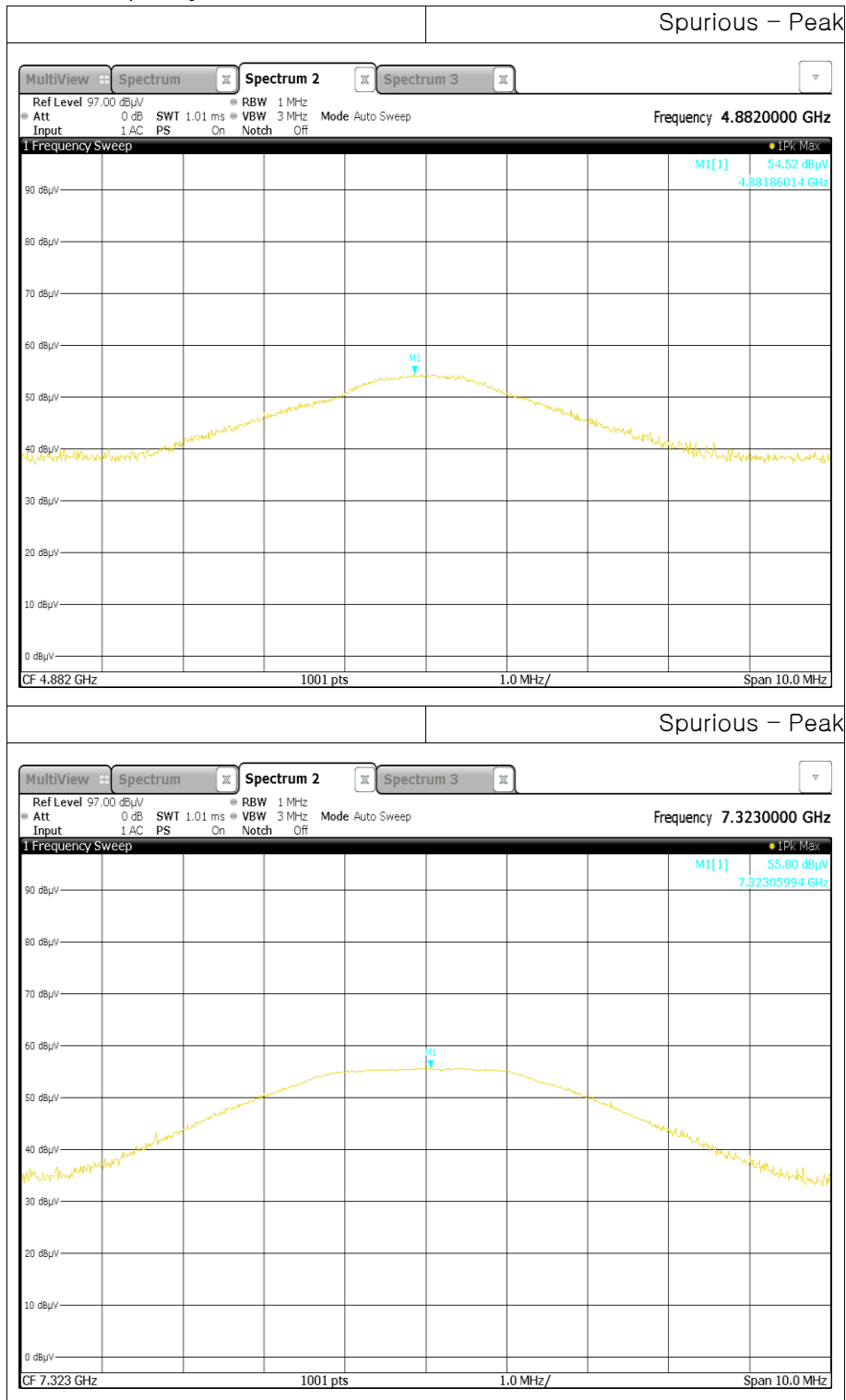
● 8DPSK _ Low frequency

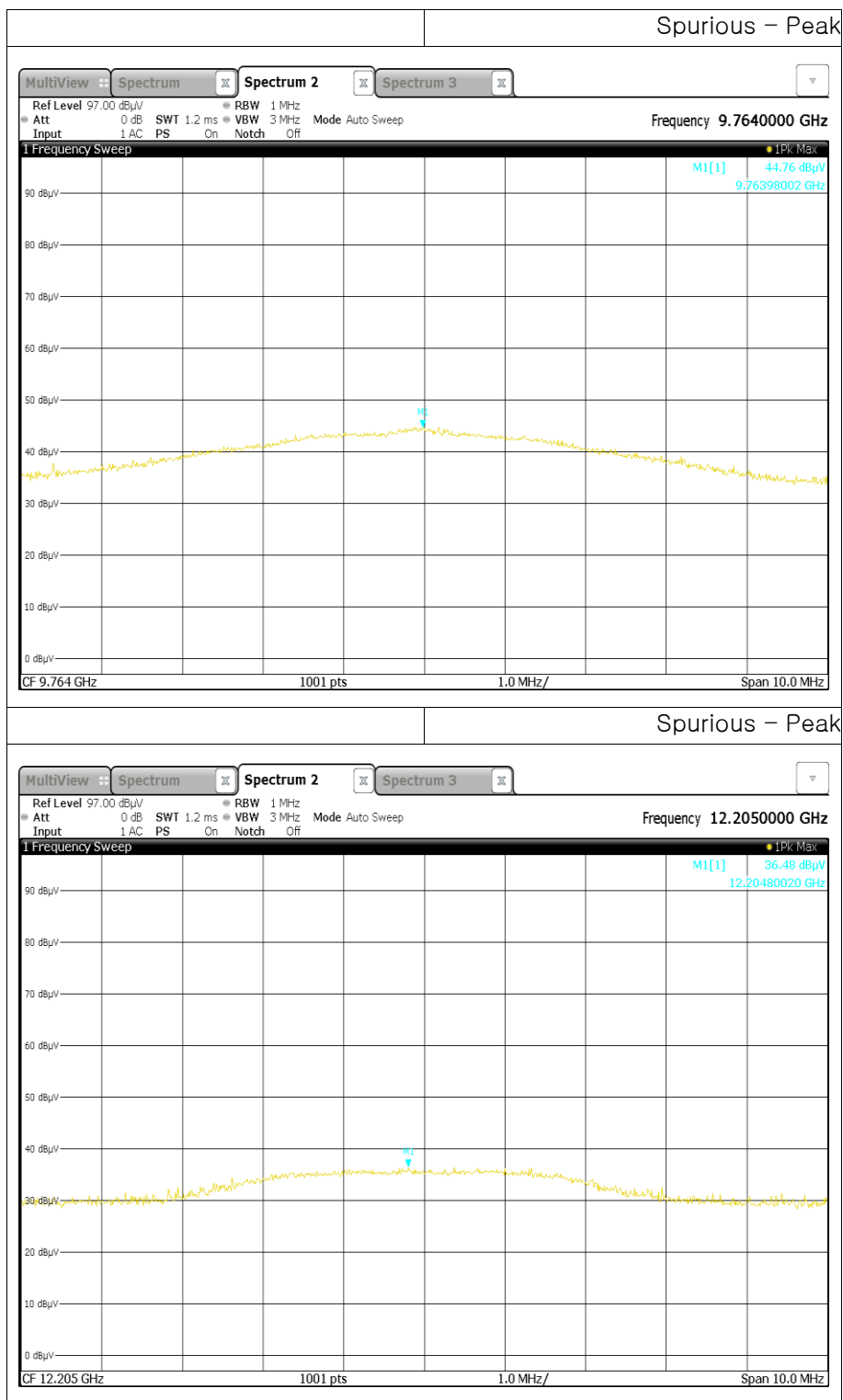




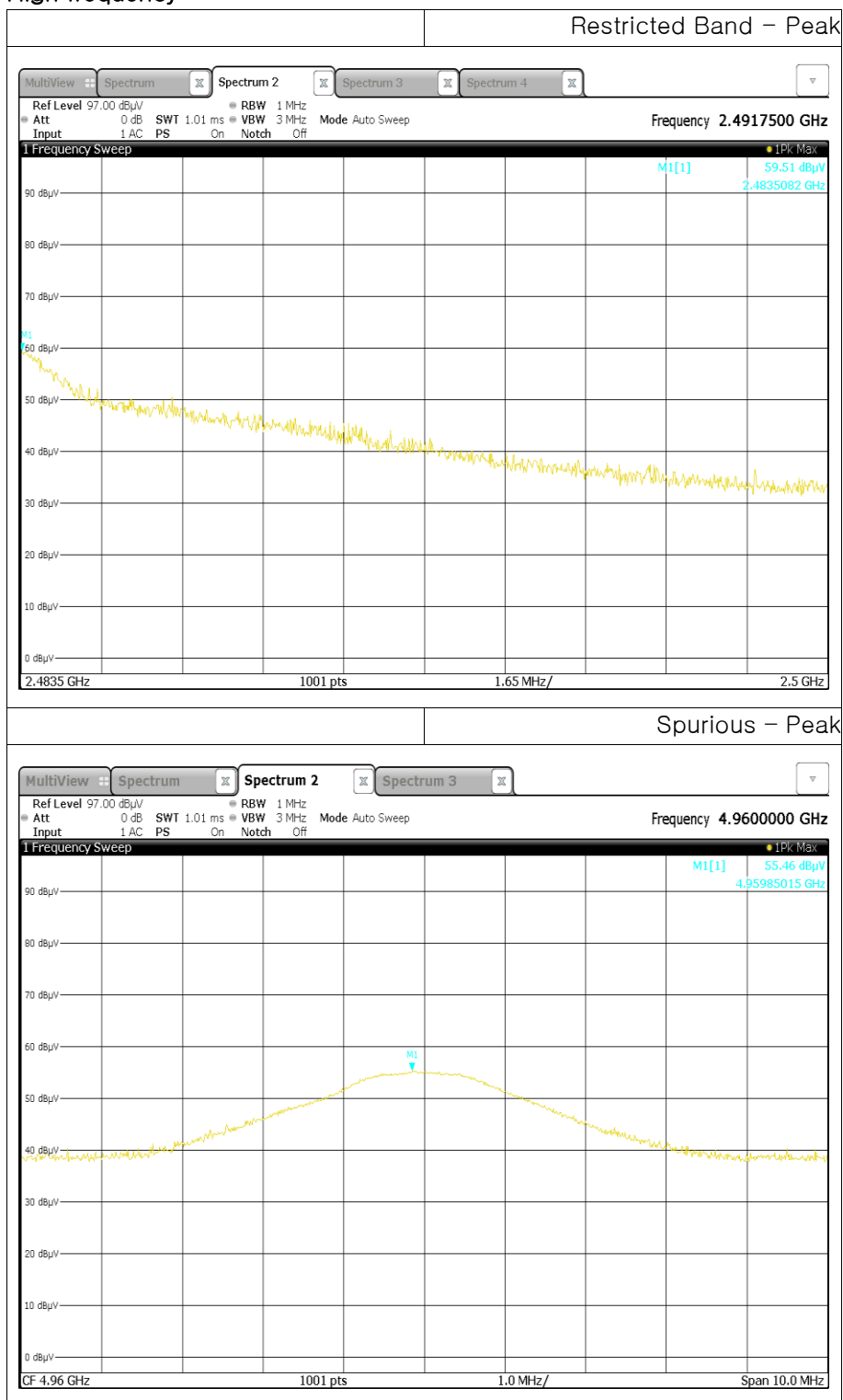


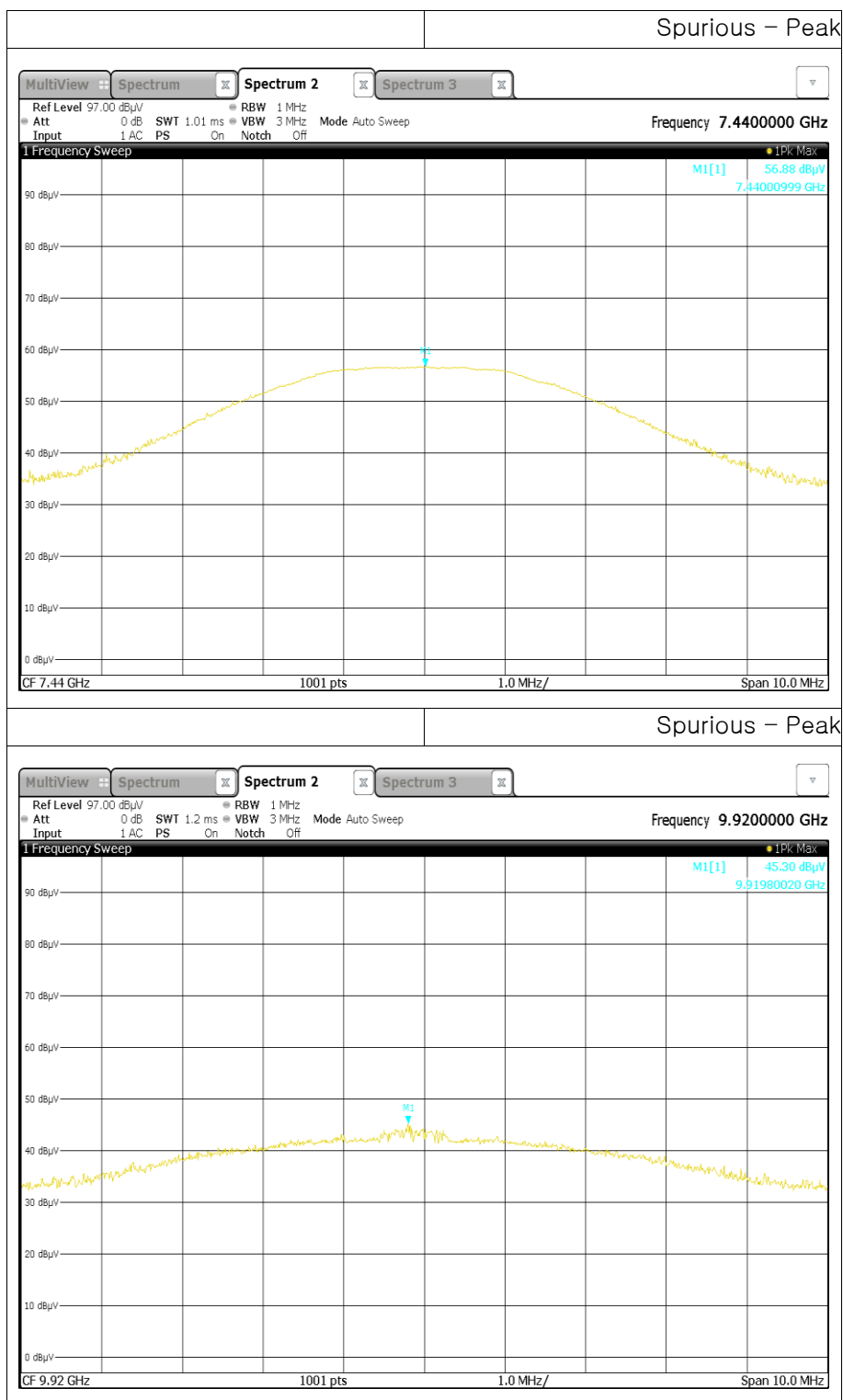
- 8DPSK _ Middle frequency

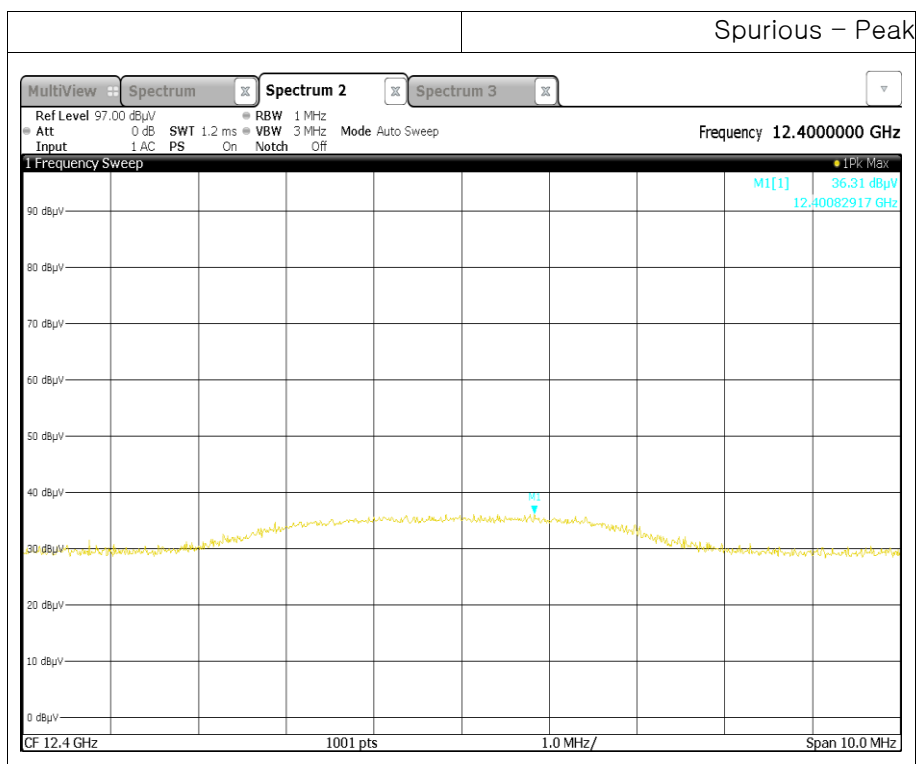




● 8DPSK _ High frequency

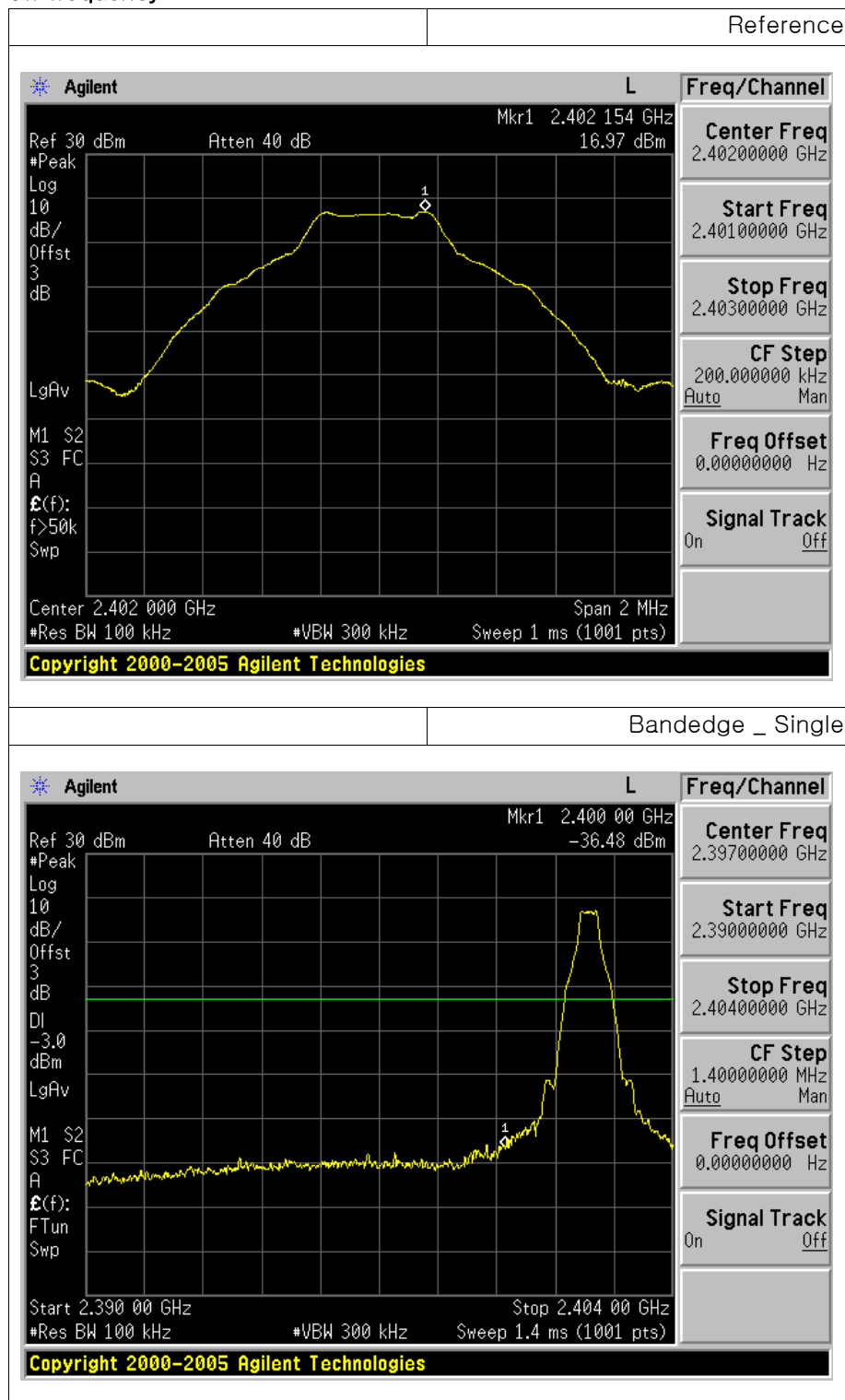


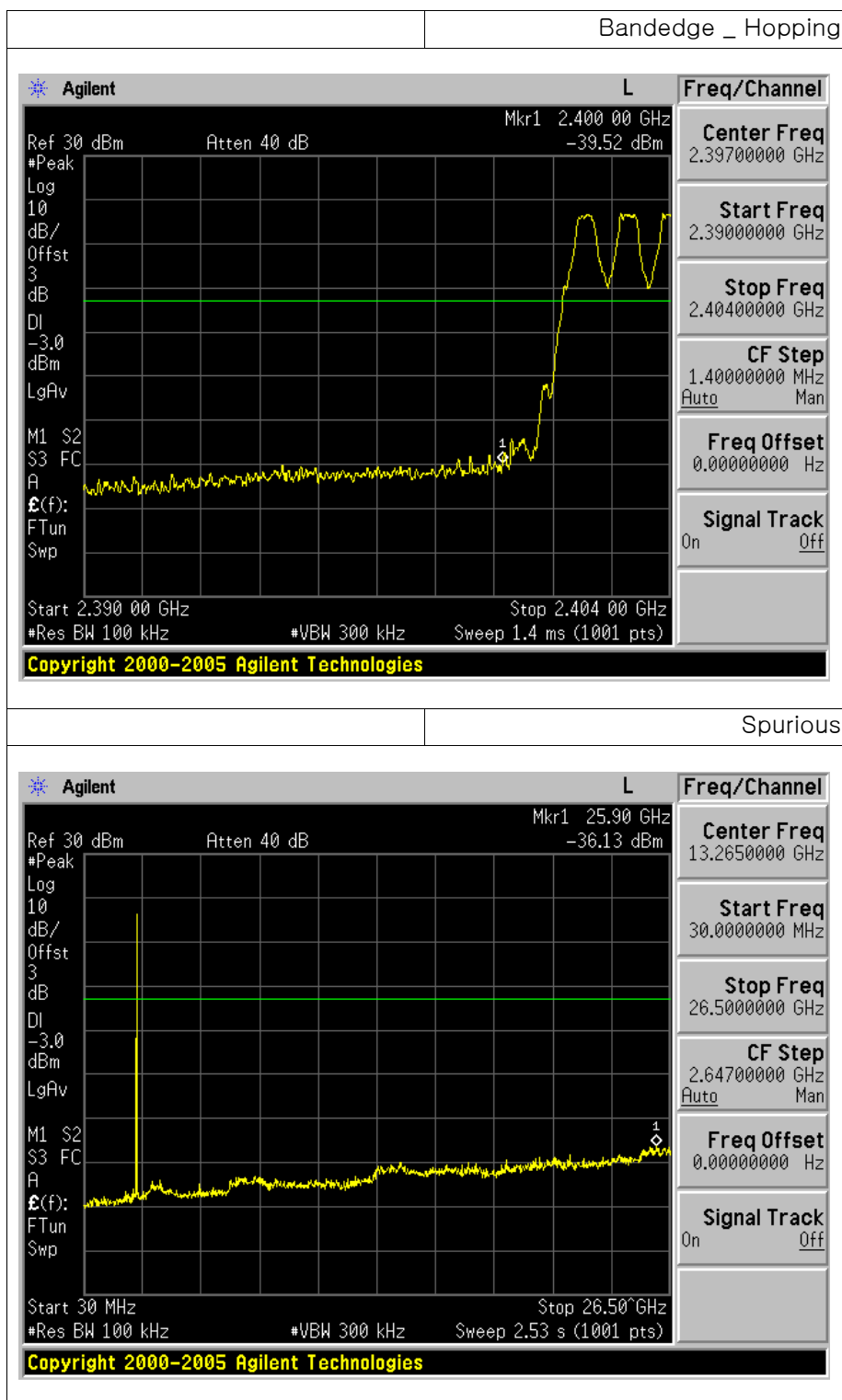




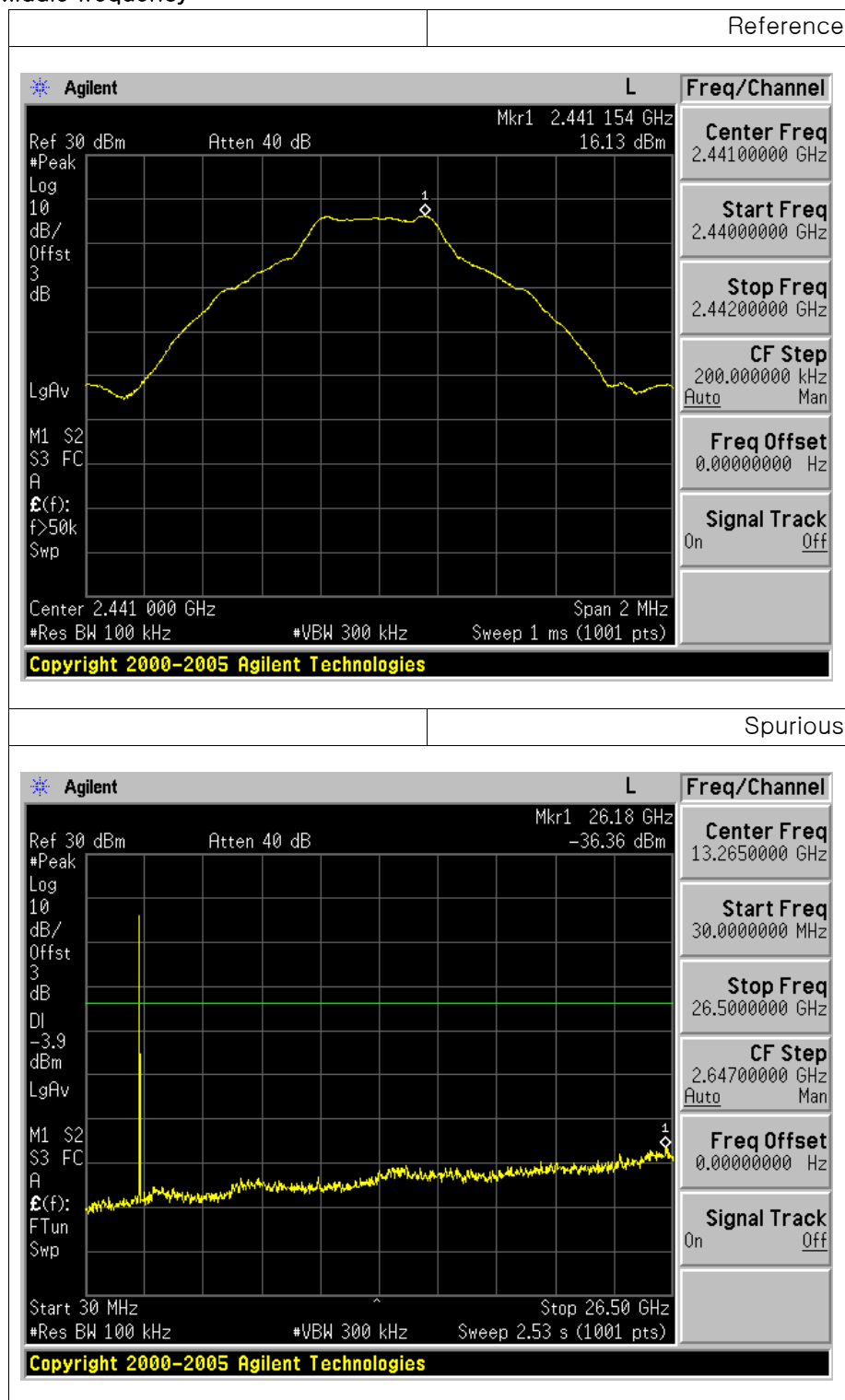
11.7 Test Plot for Conducted Spurious Emission

- GFSK _ Low frequency



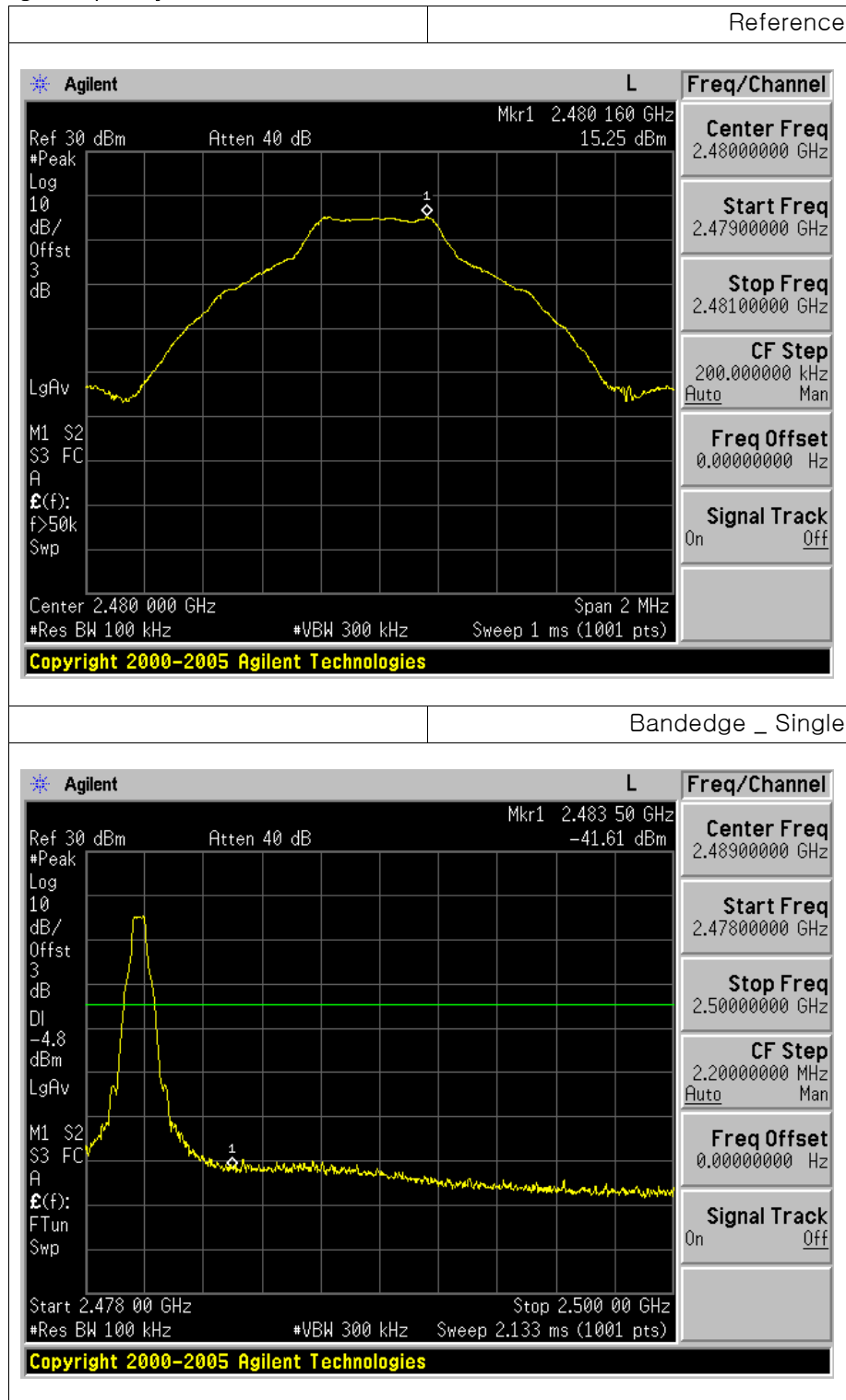


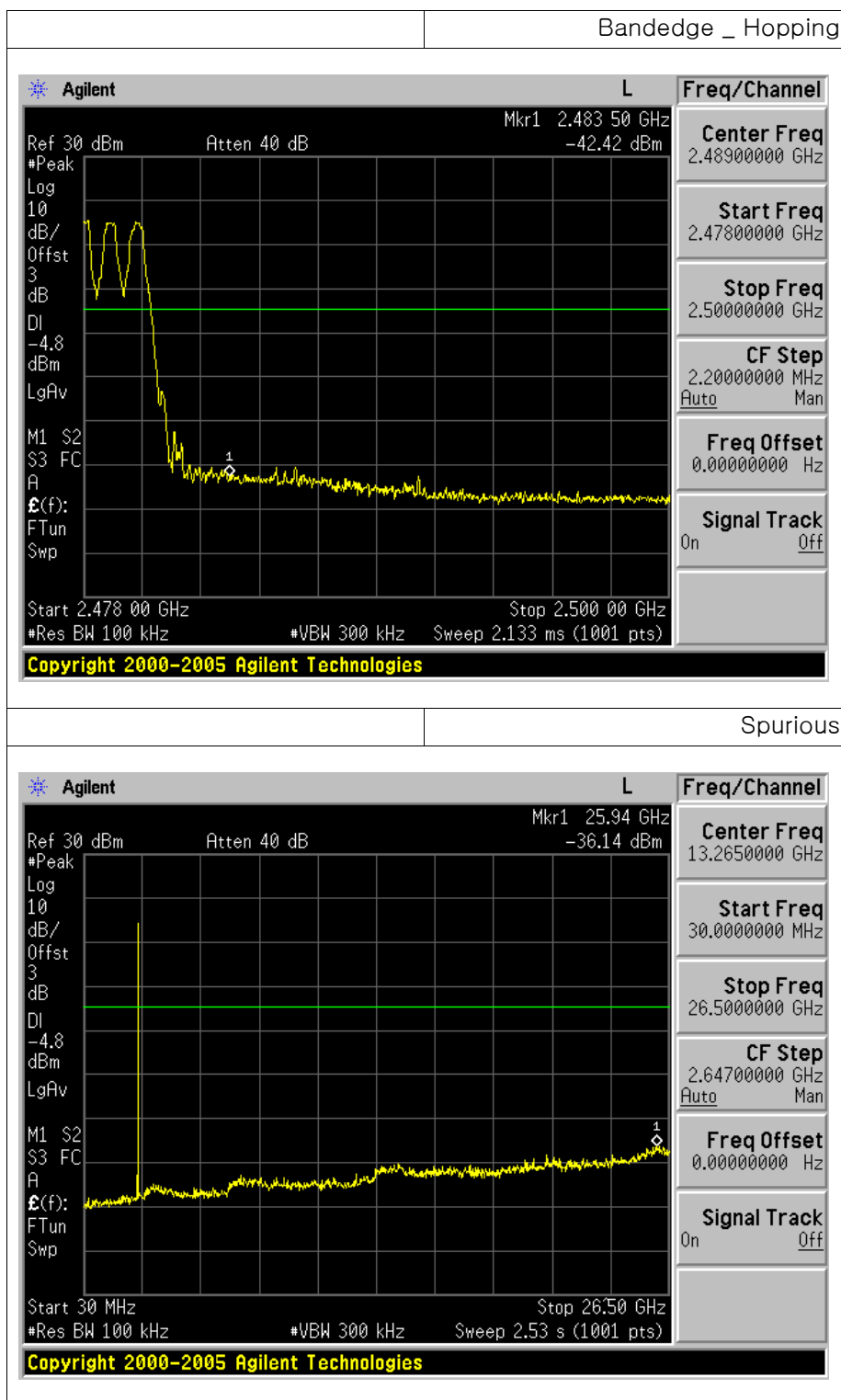
● GFSK _ Middle frequency



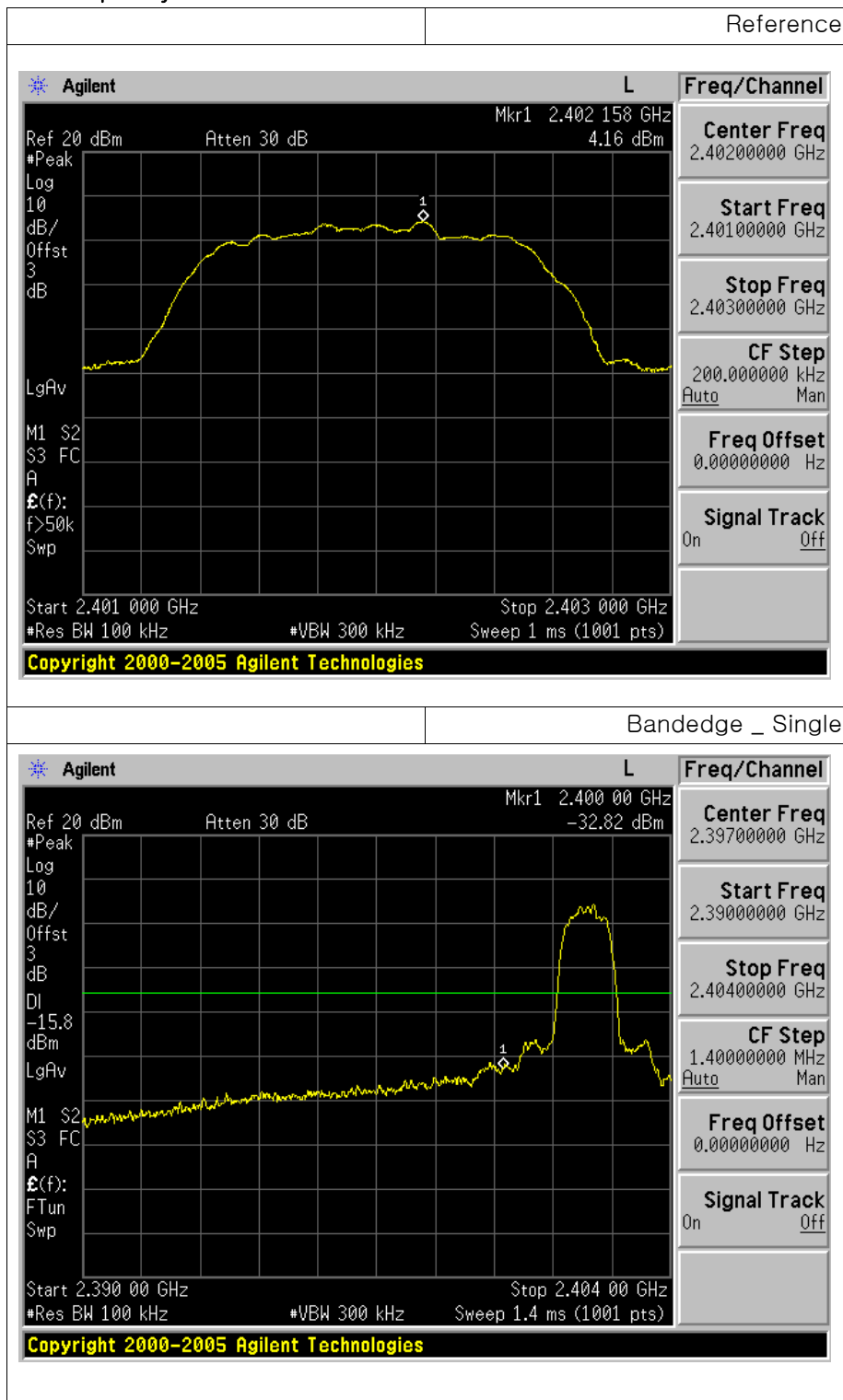


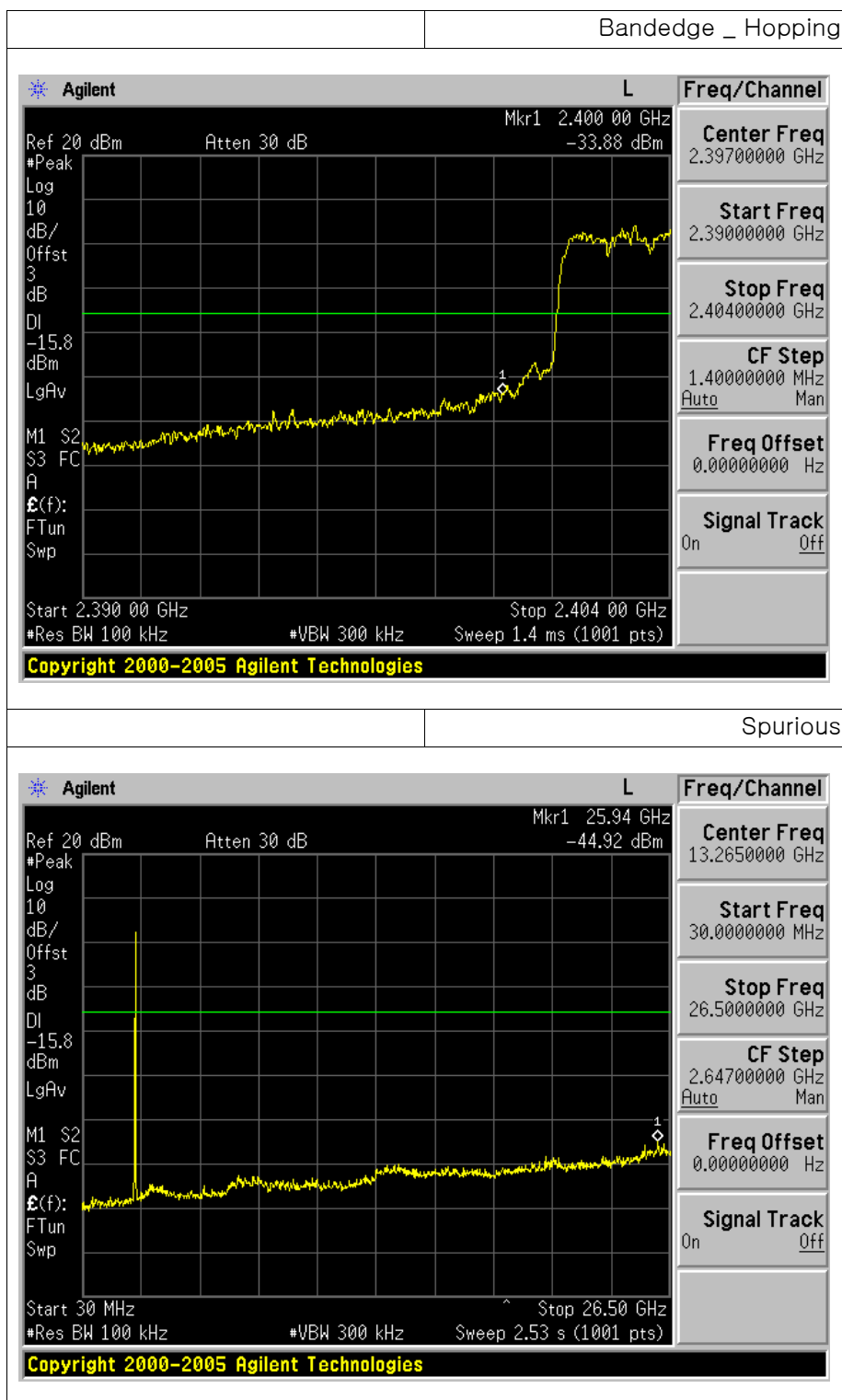
- GFSK _ High frequency



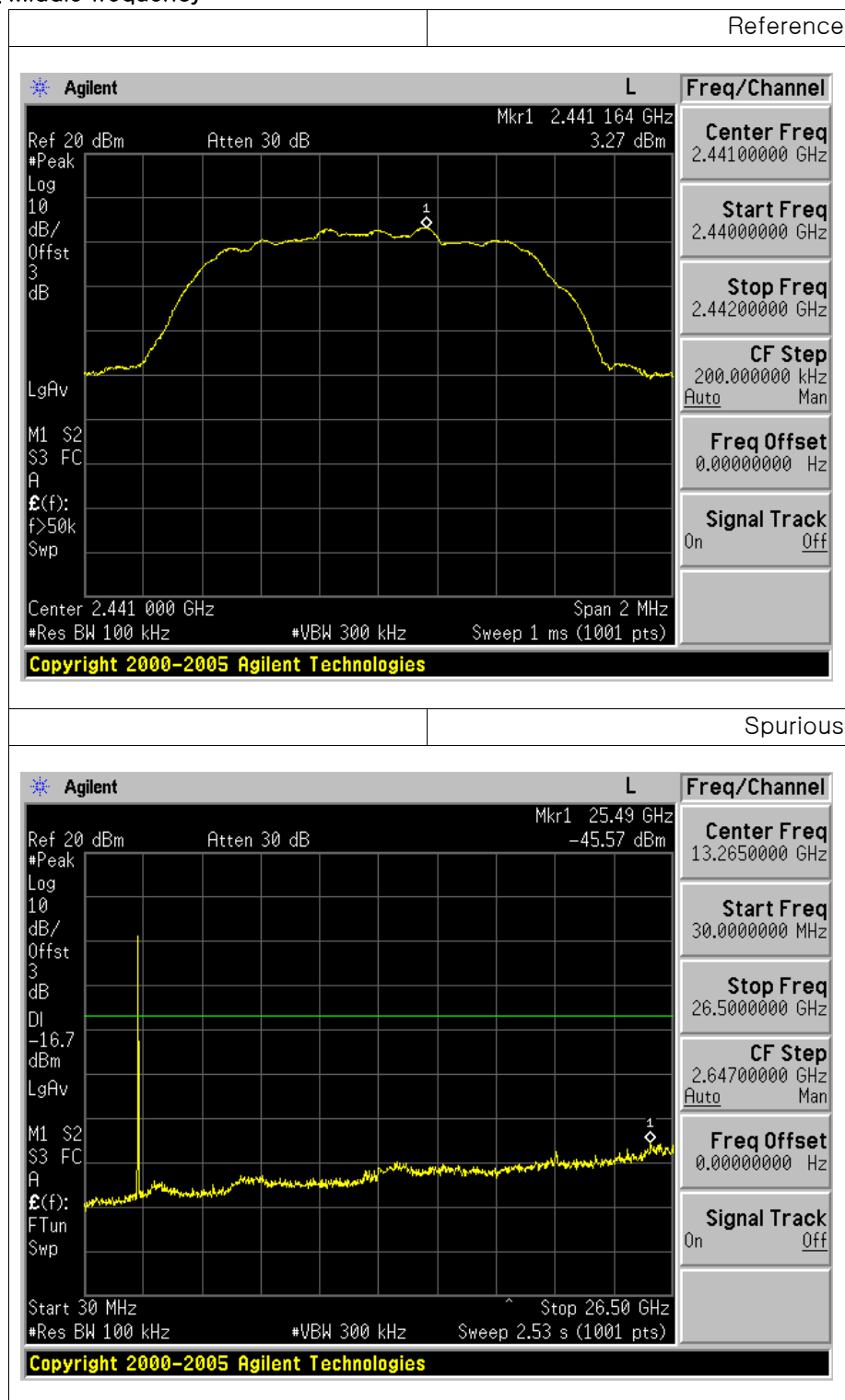


● 8DPSK _ Low frequency

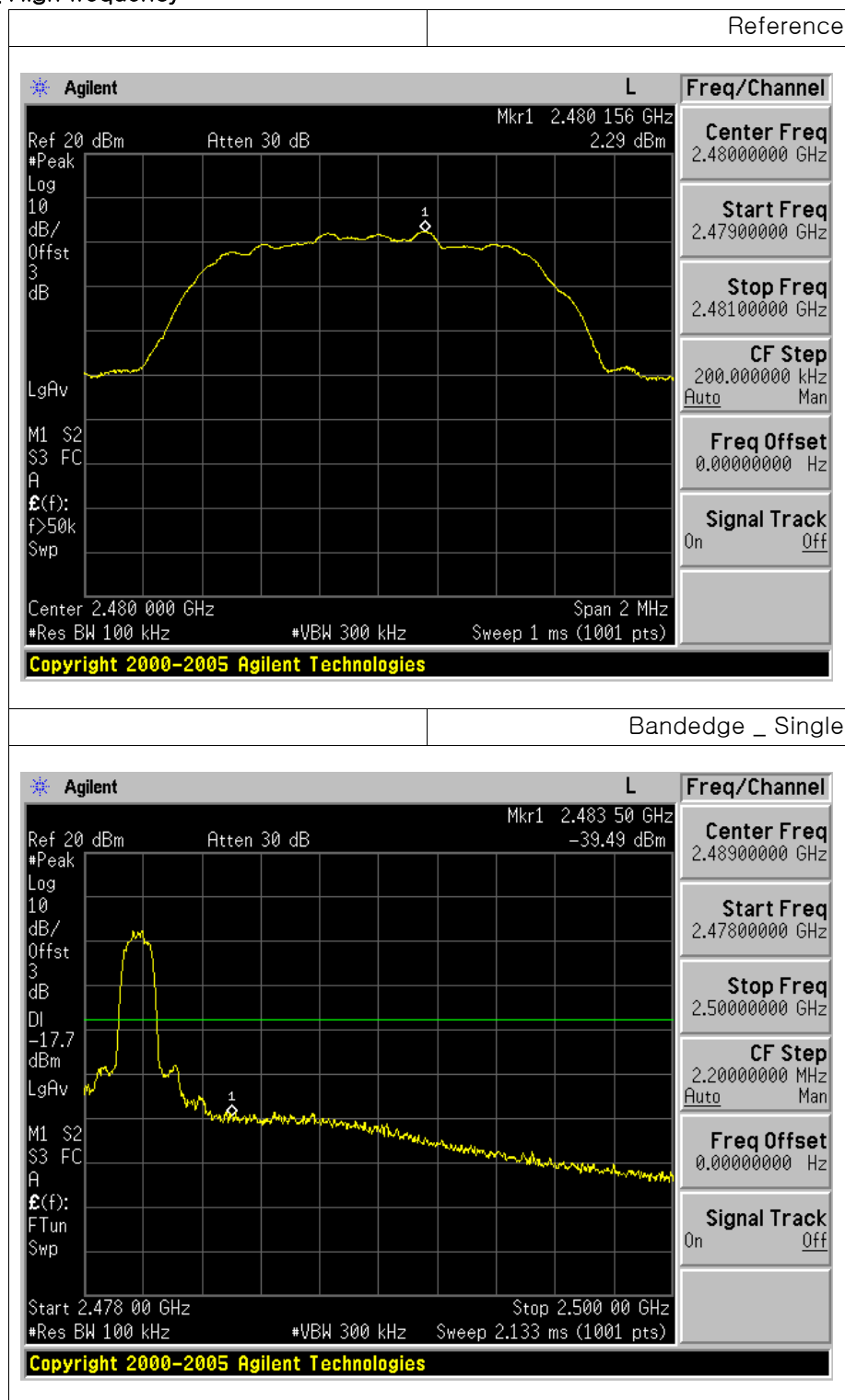


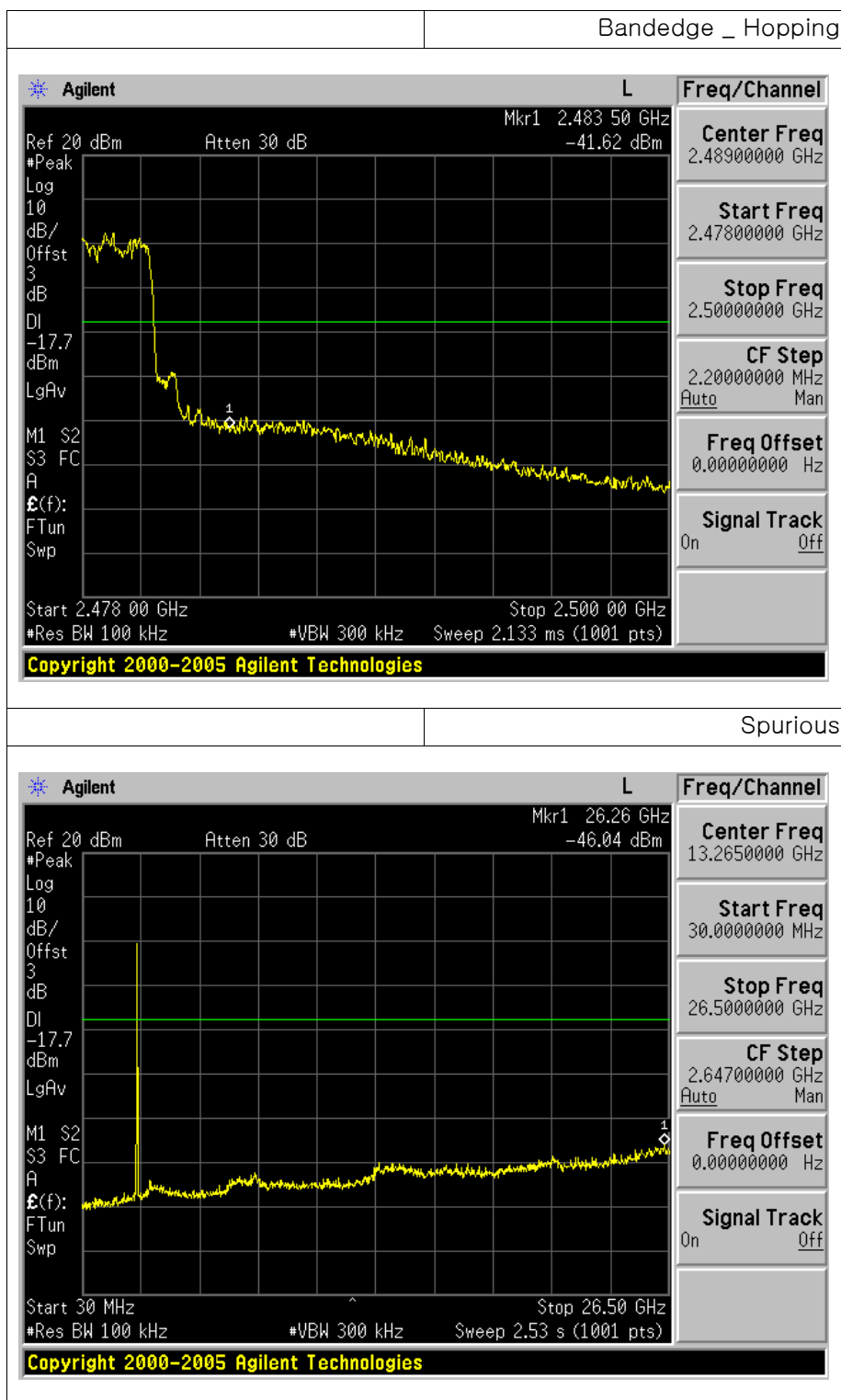


● 8DPSK _ Middle frequency



● 8DPSK _ High frequency







12. Conducted Emission

12.1 Test Setup

See test photographs for the actual connections between EUT and support equipment.

12.2 Limit

According to §15.207(a) for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohm line impedance stabilization network (LISN).

Compliance with the provision of this paragraph shall on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower applies at the boundary between the frequency ranges.

Frequency Range (MHz)	Conducted Limit (dBuV)	
	Quasi-Peak	Average
0.15 ~ 0.5	66 to 56 *	56 to 46 *
0.5 ~ 5	56	46
5 ~ 30	60	50

* Decreases with the logarithm of the frequency

12.3 Test Procedure

Conducted emissions from the EUT were measured according to the ANSI C63.10.

1. The test procedure is performed in a 6.5 m $\times$ 3.5 m $\times$ 3.5 m (L $\times$ W $\times$ H) shielded room. The EUT along with its peripherals were placed on a 1.0 m (W) $\times$ 1.5 m (L) and 0.8 m in height wooden table and the EUT was adjusted to maintain a 0.4 meter space from a vertical reference plane.
2. The EUT was connected to power mains through a line impedance stabilization network (LISN) which provides 50 ohm coupling impedance for measuring instrument and the chassis ground was bounded to the horizontal ground plane of shielded room.
3. All peripherals were connected to the second LISN and the chassis ground also bounded to the horizontal ground plane of shielded room.
4. The excess power cable between the EUT and the LISN was bundled. The power cables of peripherals were unbundled. All connecting cables of EUT and peripherals were moved to find the maximum emission.

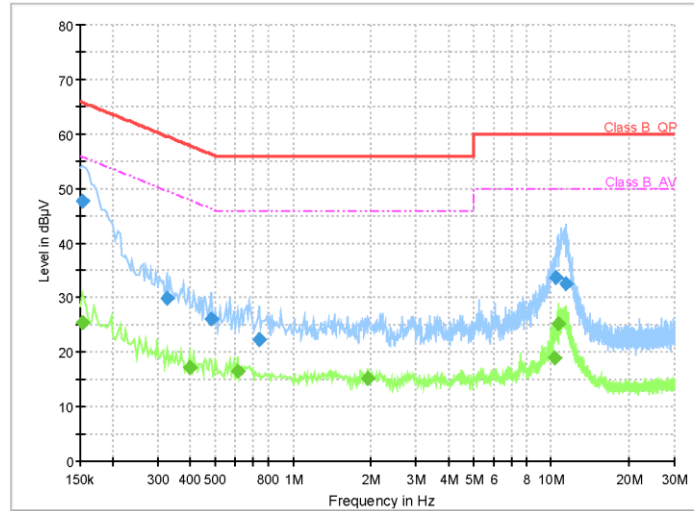


12.4 Test Result

- AC Line Conducted Emission (Graph)

10R 2_BT_L1

Power Interference

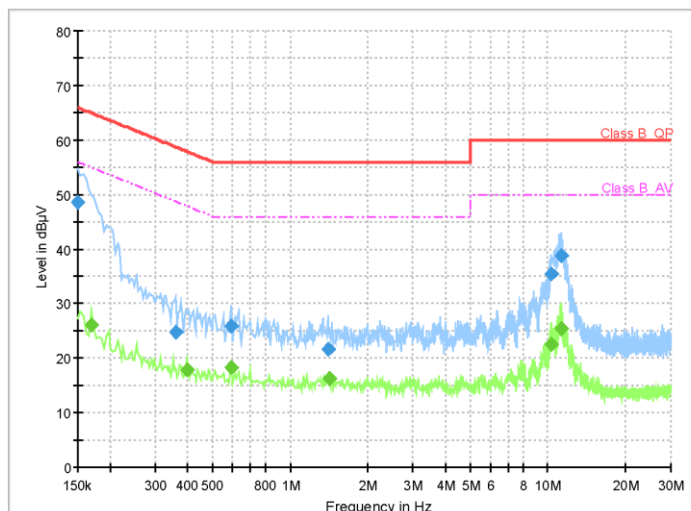


Final Result

Frequency (MHz)	QuasiPeak (dBµV)	CAverage (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter
0.154	---	25.30	55.78	30.49	9	L1	ON
0.154	47.71	---	65.78	18.07	9	L1	ON
0.326	29.90	---	59.55	29.66	9	L1	ON
0.398	---	17.06	47.90	30.83	9	L1	ON
0.482	26.15	---	56.31	30.16	9	L1	ON
0.610	---	16.51	46.00	29.49	9	L1	ON
0.740	22.25	---	56.00	33.75	9	L1	ON
1.960	---	15.06	46.00	30.94	9	L1	ON
10.330	---	19.04	50.00	30.96	9	L1	ON
10.370	33.67	---	60.00	26.33	9	L1	ON
10.700	---	25.25	50.00	24.75	9	L1	ON
11.350	32.62	---	60.00	27.38	9	L1	ON

10R 2_BT_N

Power Interference



Final Result

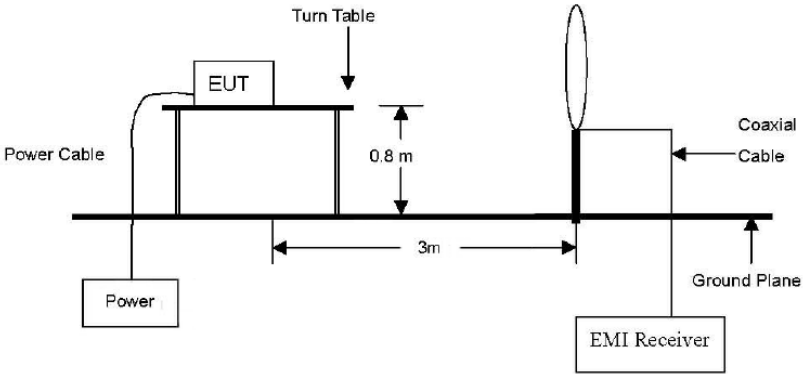
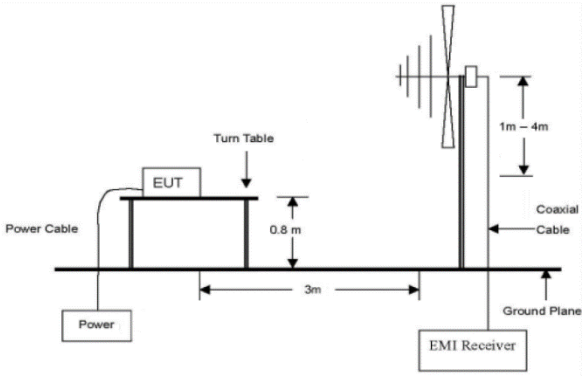
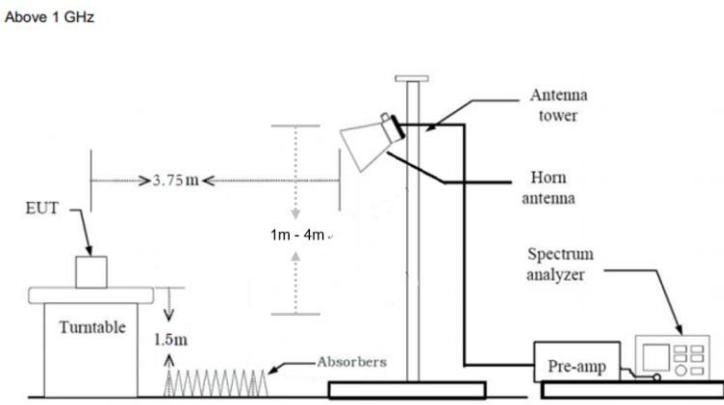
Frequency (MHz)	QuasiPeak (dBµV)	CAverage (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter
0.150	48.61	---	66.00	17.39	9	N	ON
0.170	---	26.01	54.96	28.95	9	N	ON
0.362	24.77	---	58.68	33.91	9	N	ON
0.398	---	17.87	47.90	30.02	9	N	ON
0.590	---	18.17	46.00	27.83	9	N	ON
0.590	25.94	---	56.00	30.06	9	N	ON
1.400	21.63	---	56.00	34.37	9	N	ON
1.430	---	16.18	46.00	29.82	9	N	ON
10.350	35.52	---	60.00	24.48	9	N	ON
10.360	---	22.41	50.00	27.59	9	N	ON
11.220	---	25.46	50.00	24.54	9	N	ON
11.290	38.74	---	60.00	21.26	9	N	ON

APPENDIX I

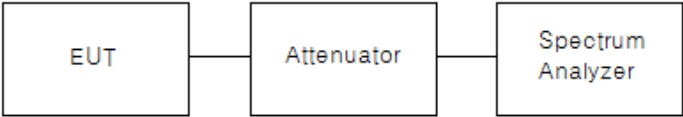
TEST SETUP



● Radiated Measurement

below 30 MHz	
below 1 GHz	
above 1 GHz	

● Conducted Measurement

Conducted	
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APPENDIX II

UNCERTAINTY



Measurement Item	Expanded Uncertainty $U = kU_c (k=2)$
Conducted RF power	0.34 dB
Conducted Spurious Emissions	0.34 dB
Radiated Spurious Emissions	5.82 dB
Conducted Emissions	2.00 dB